



US009106229B1

(12) **United States Patent**
Hutton et al.

(10) **Patent No.:** **US 9,106,229 B1**
(45) **Date of Patent:** **Aug. 11, 2015**

(54) **PROGRAMMABLE INTERPOSER CIRCUITRY**

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(*) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 216 days.

(21) Appl. No.: **13/829,965**

(22) Filed: **Mar. 14, 2013**

(51) **Int. Cl.**
H03K 19/173 (2006.01)
G06F 17/50 (2006.01)

(52) **U.S. Cl.**
CPC **H03K 19/173** (2013.01); **G06F 17/5077** (2013.01)

(58) **Field of Classification Search**
None
See application file for complete search history.

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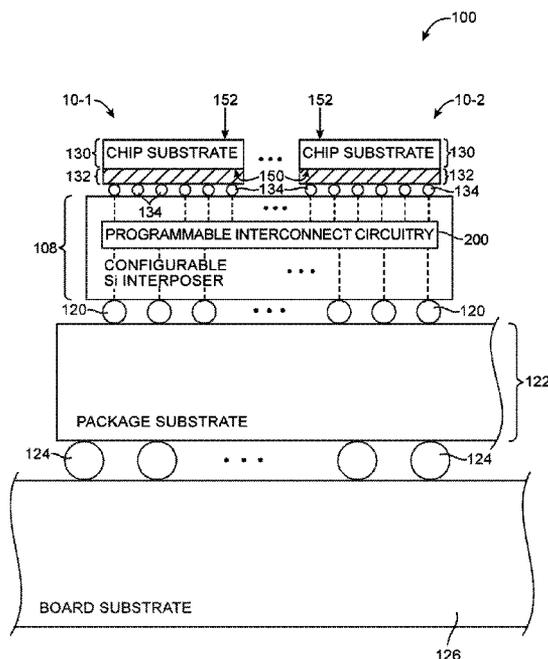
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(57) **ABSTRACT**

A multichip package that includes a programmable interposer is provided. Multiple integrated circuits may be mounted on the interposer. Active circuitry may also be embedded in the interposer device to facilitate protocol-based communications, debugging, and other desired circuit operations. The interposer device may include programmable interconnect routing circuitry that serves primarily to provide routing for the different circuits within the multichip package. A design tool may be used to design the interposer device. The design tool may include a standard die footprint library from which standard interface templates can be selected when designing an interposer device that has to communicate various on-interposer integrated circuits. The use of standard die footprints may simplify the design of interposers by enabling a family of devices to interface with a given interposer.

21 Claims, 18 Drawing Sheets



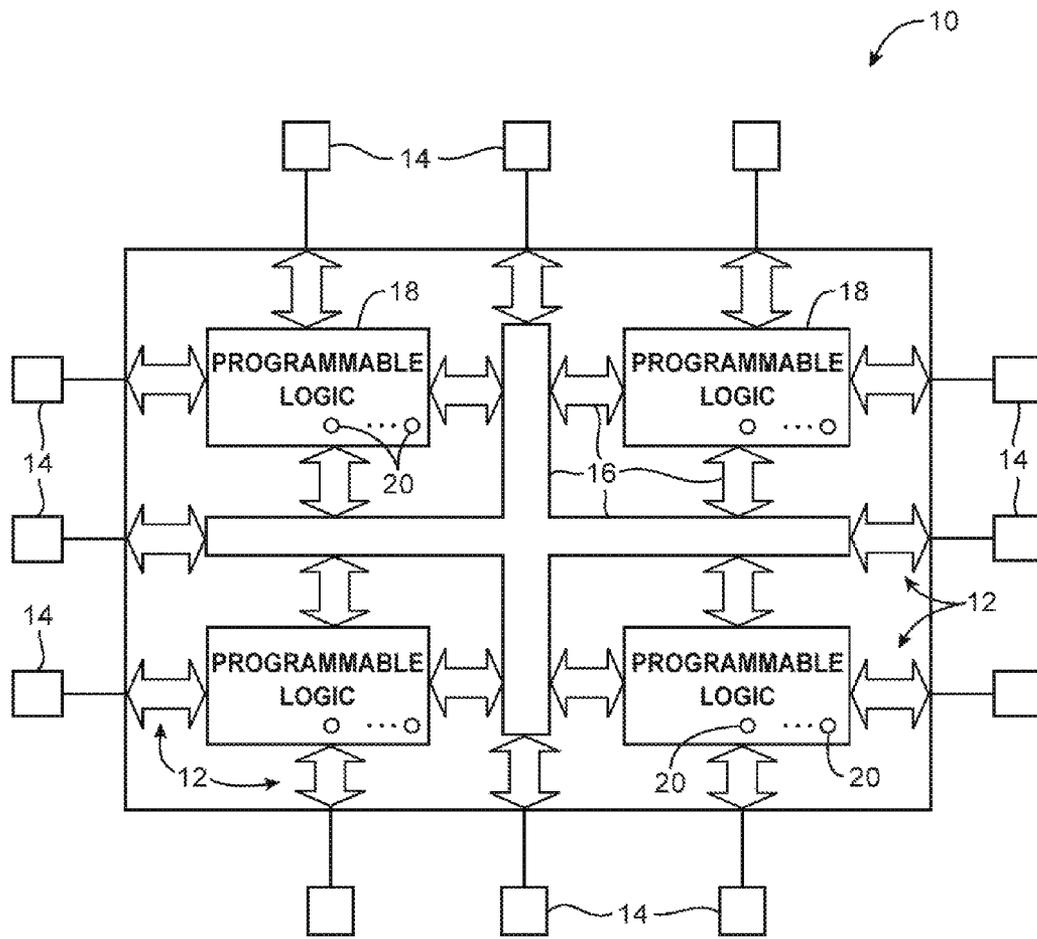


FIG. 1

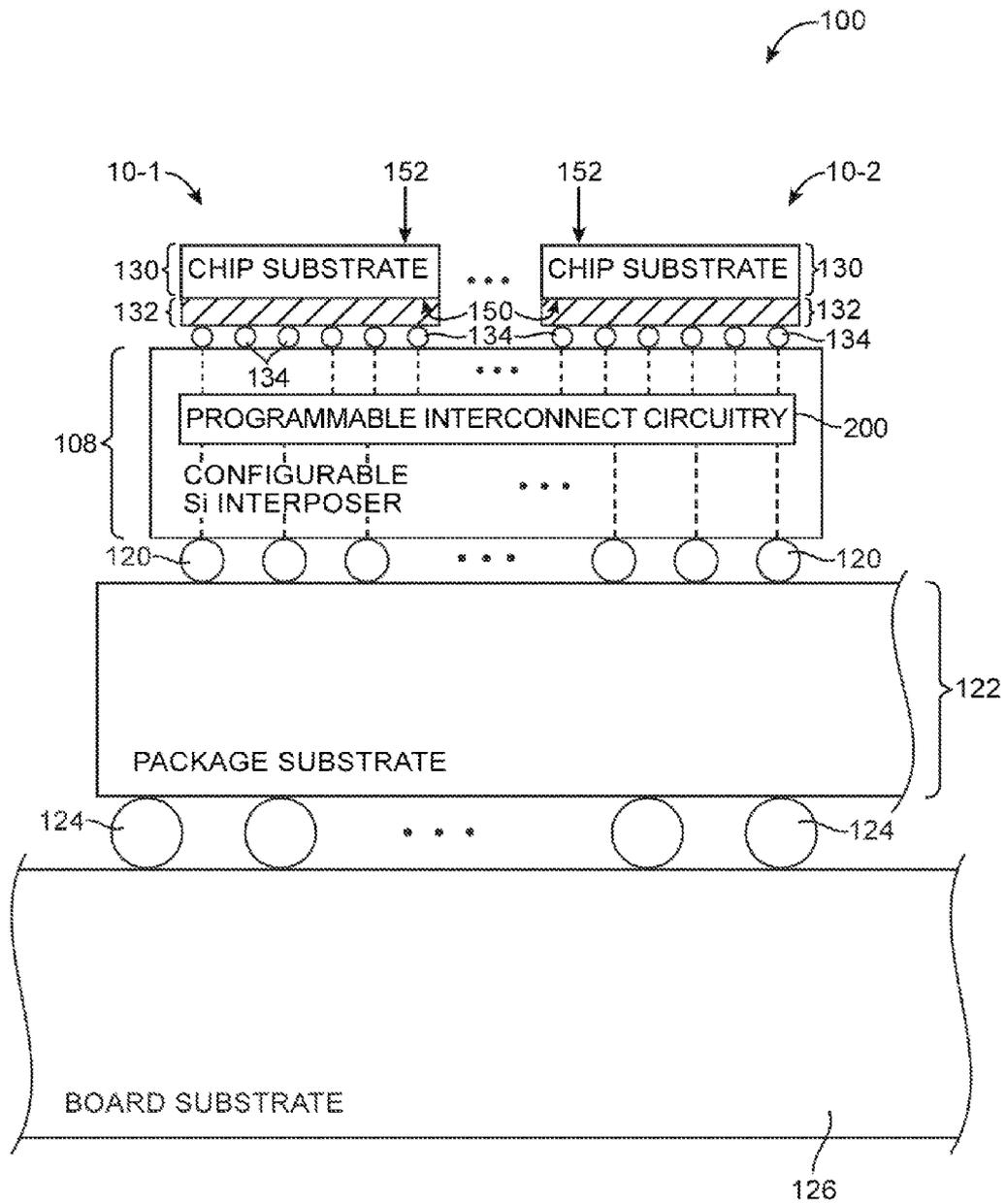


FIG. 2

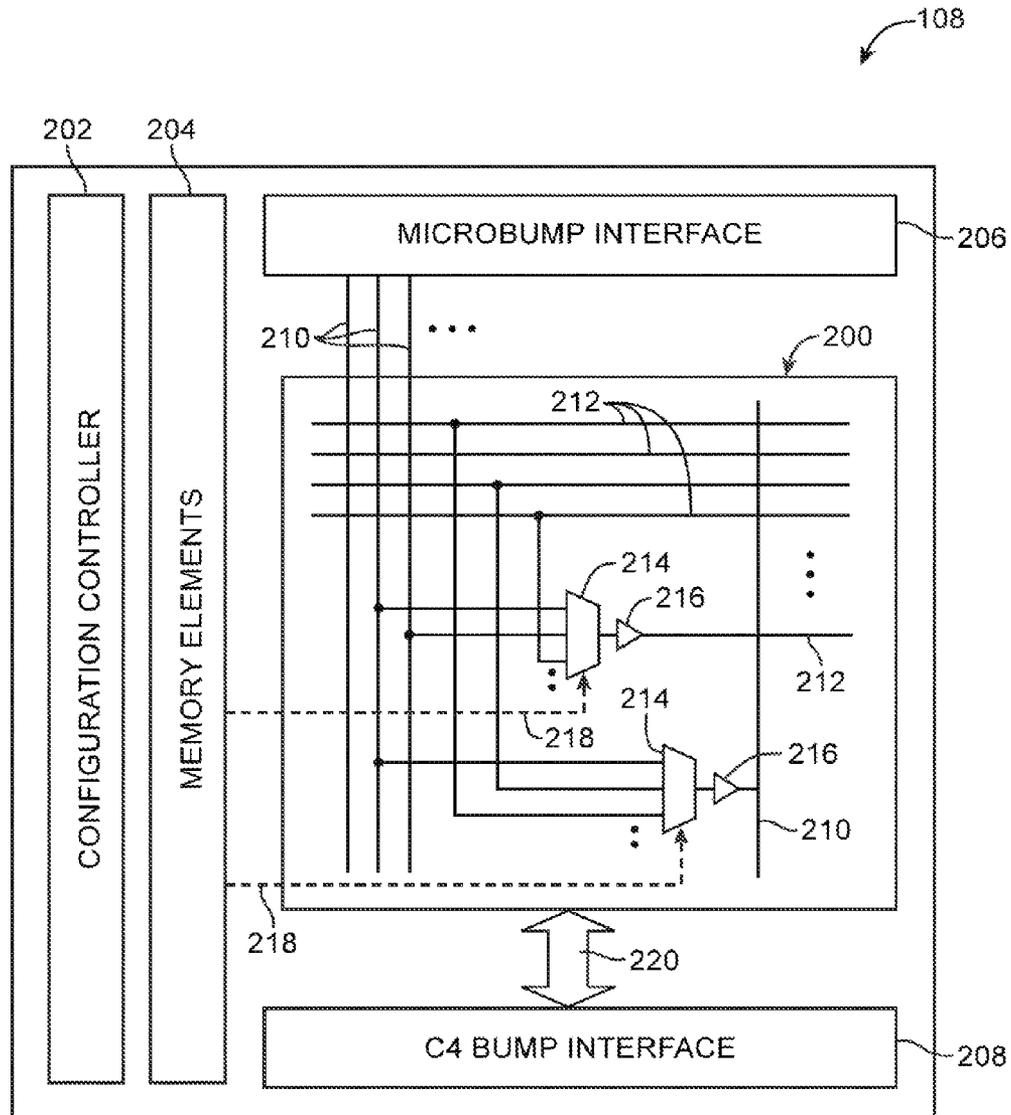


FIG. 3

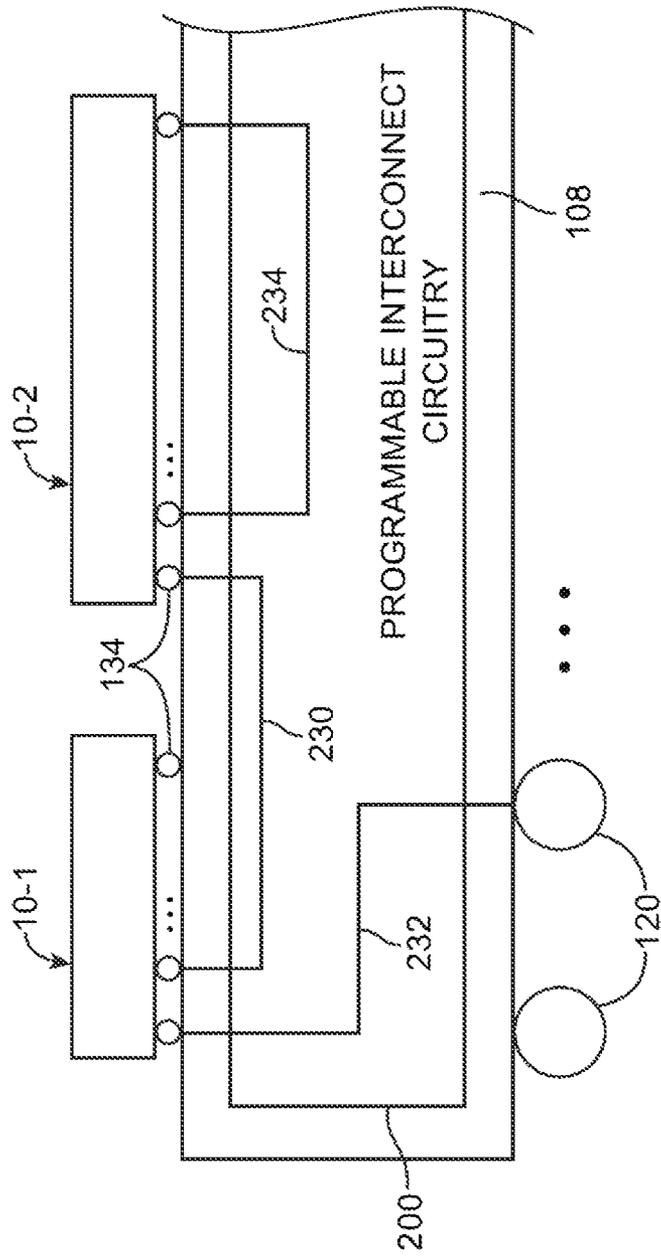


FIG. 5

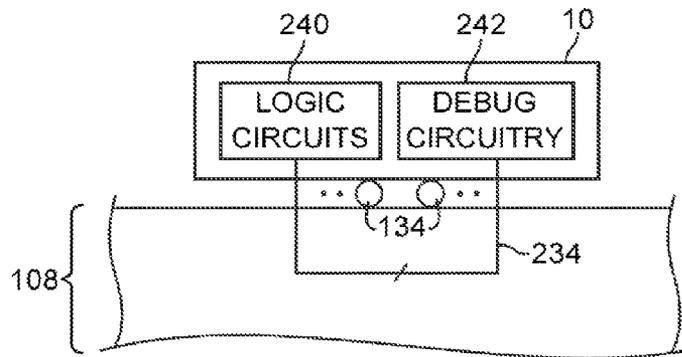


FIG. 6

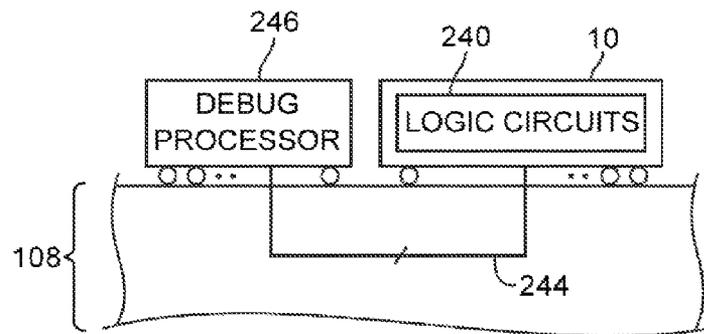


FIG. 7A

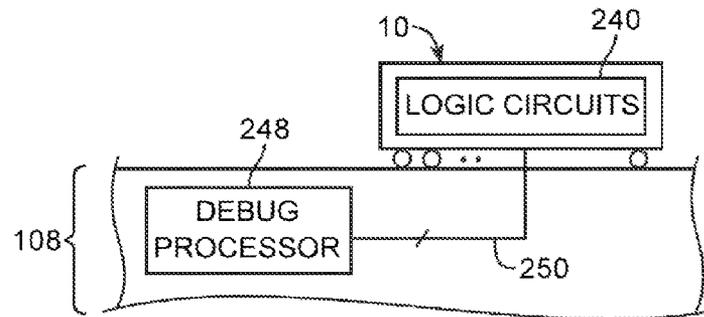


FIG. 7B

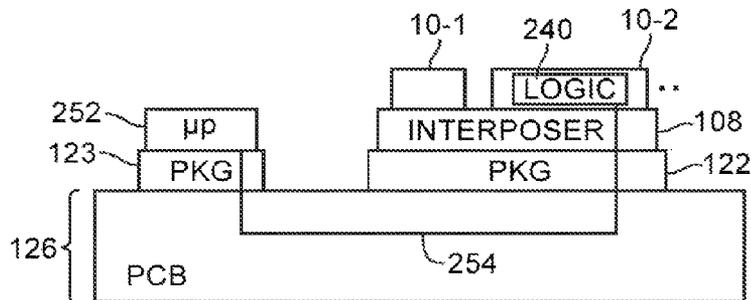


FIG. 7C

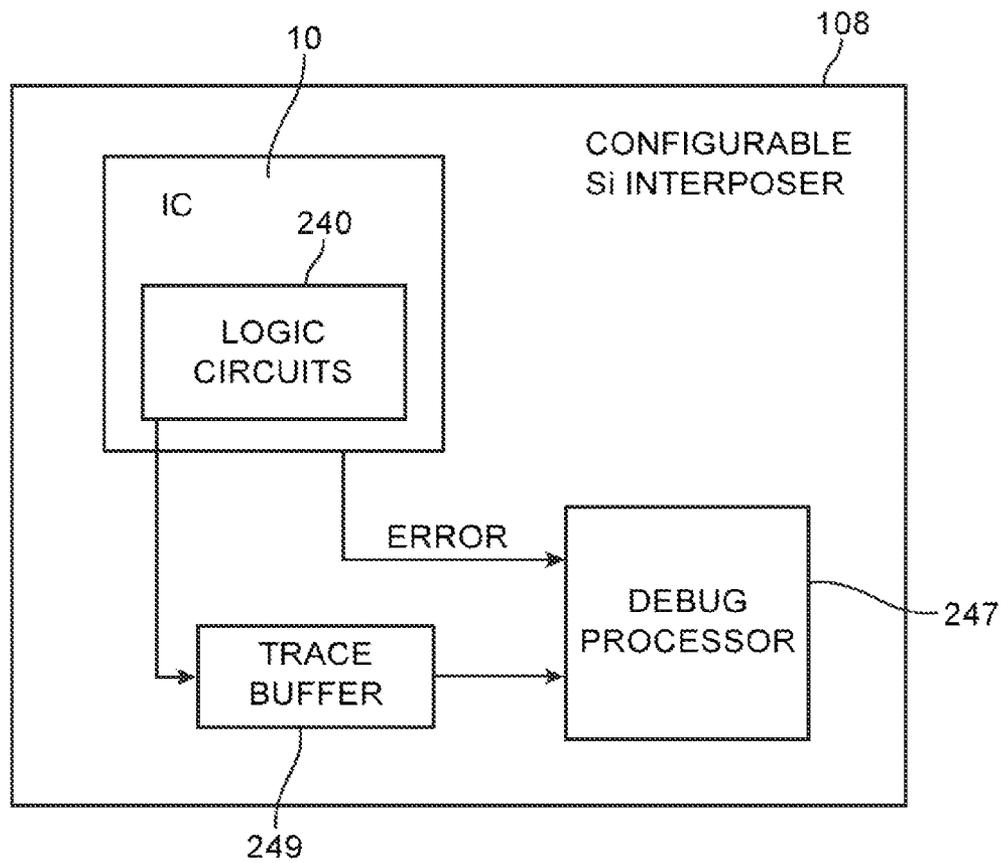


FIG. 8

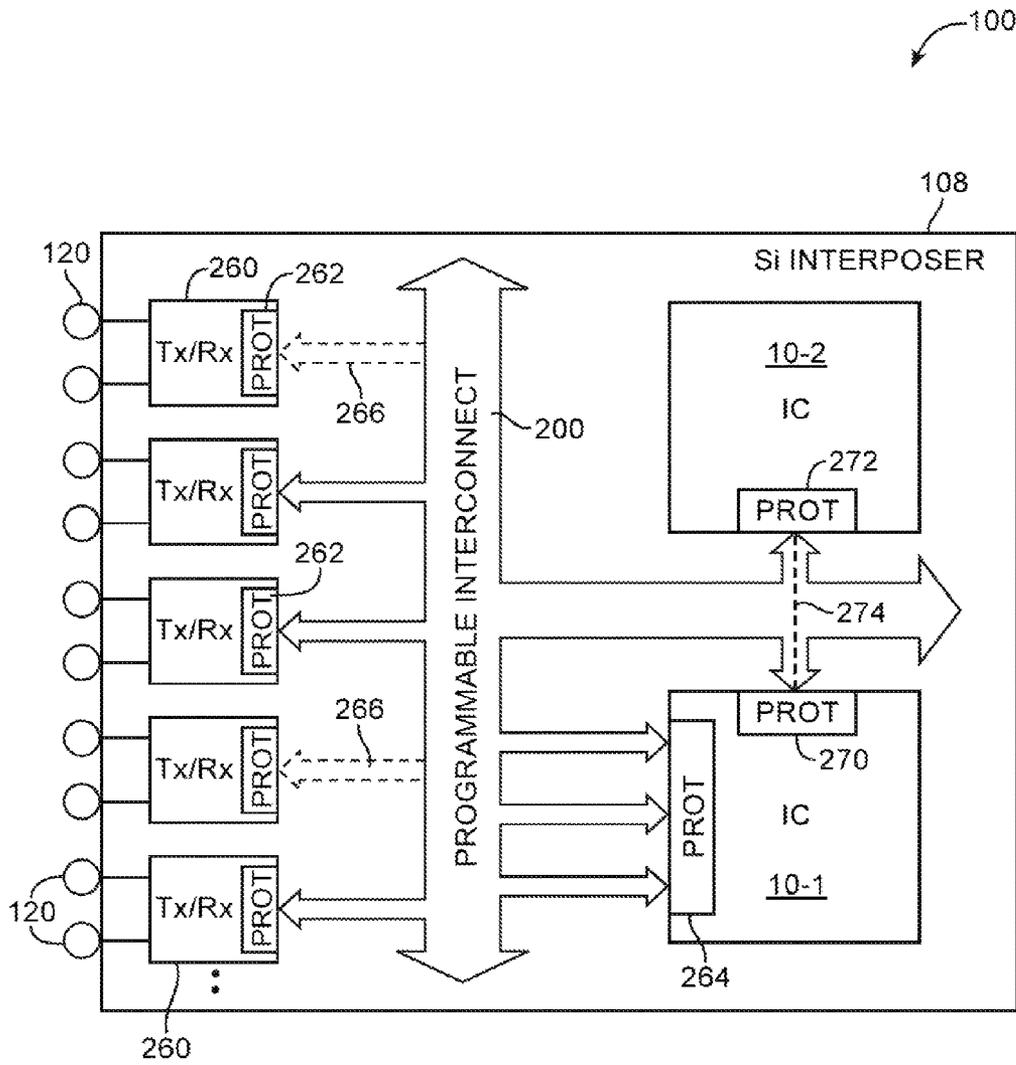


FIG. 9

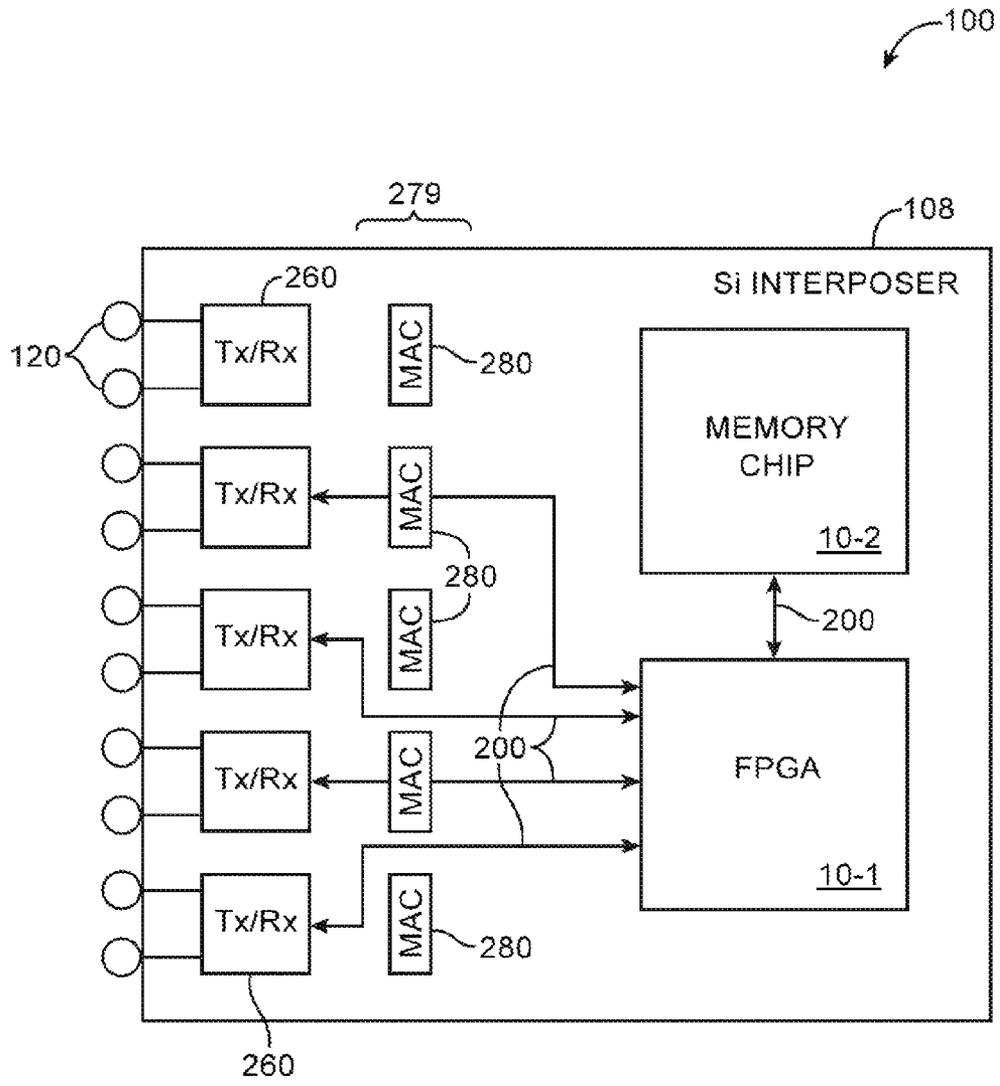


FIG. 10A

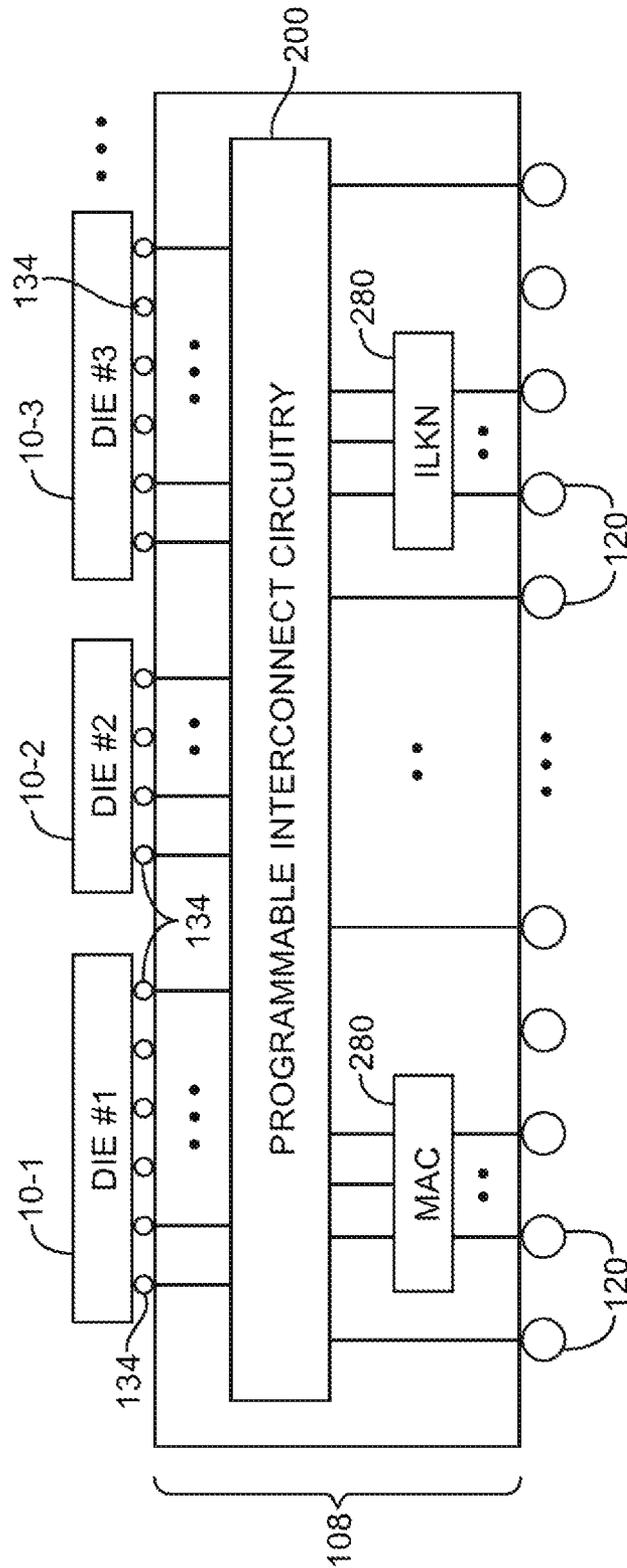


FIG. 10B

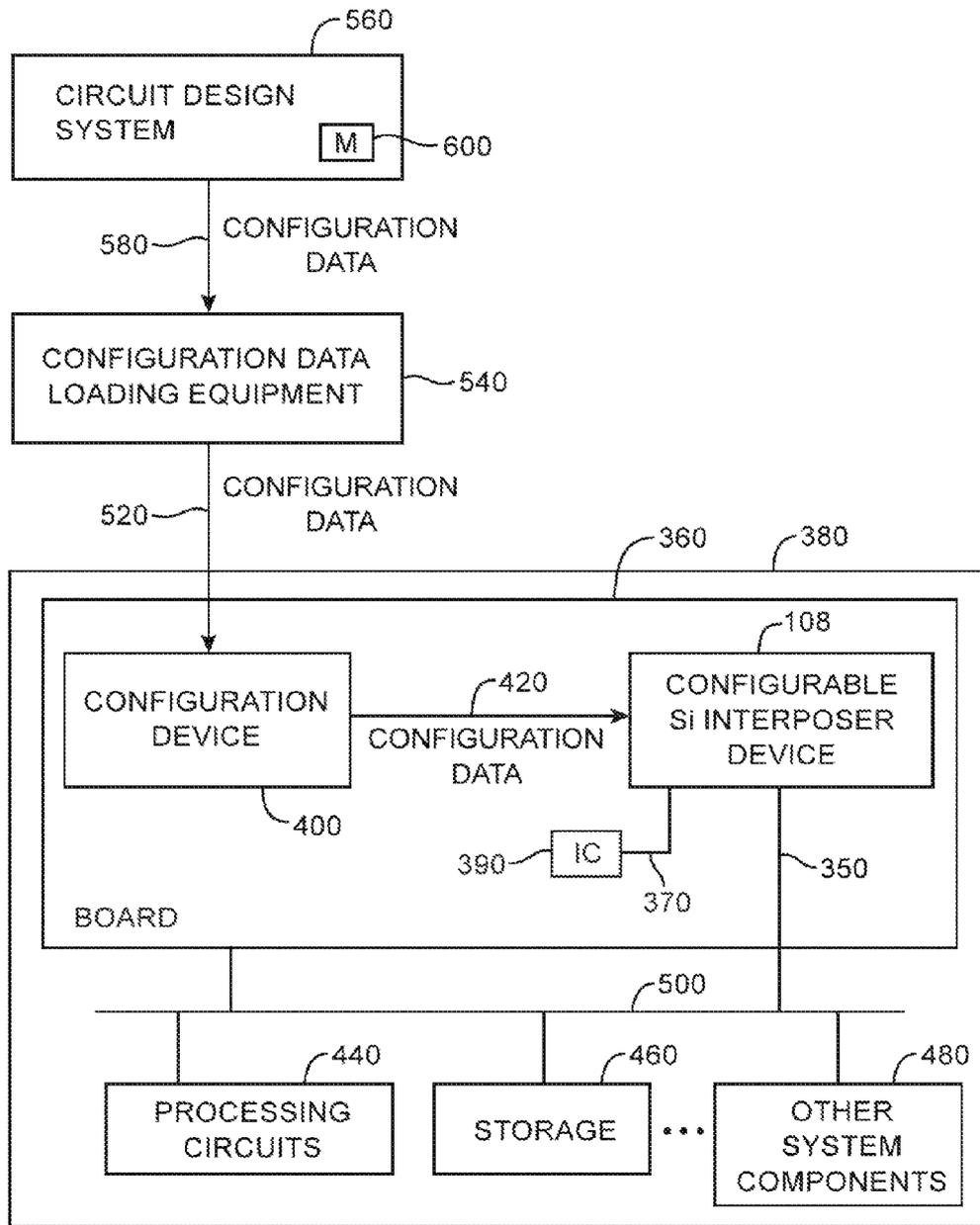


FIG. 11

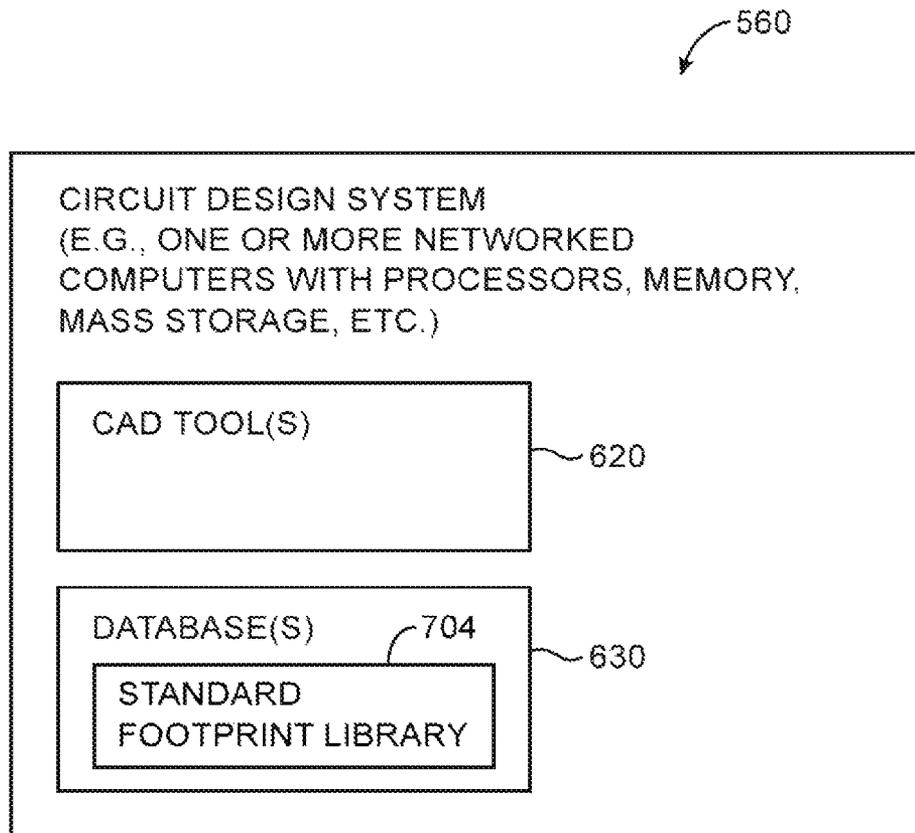


FIG. 12

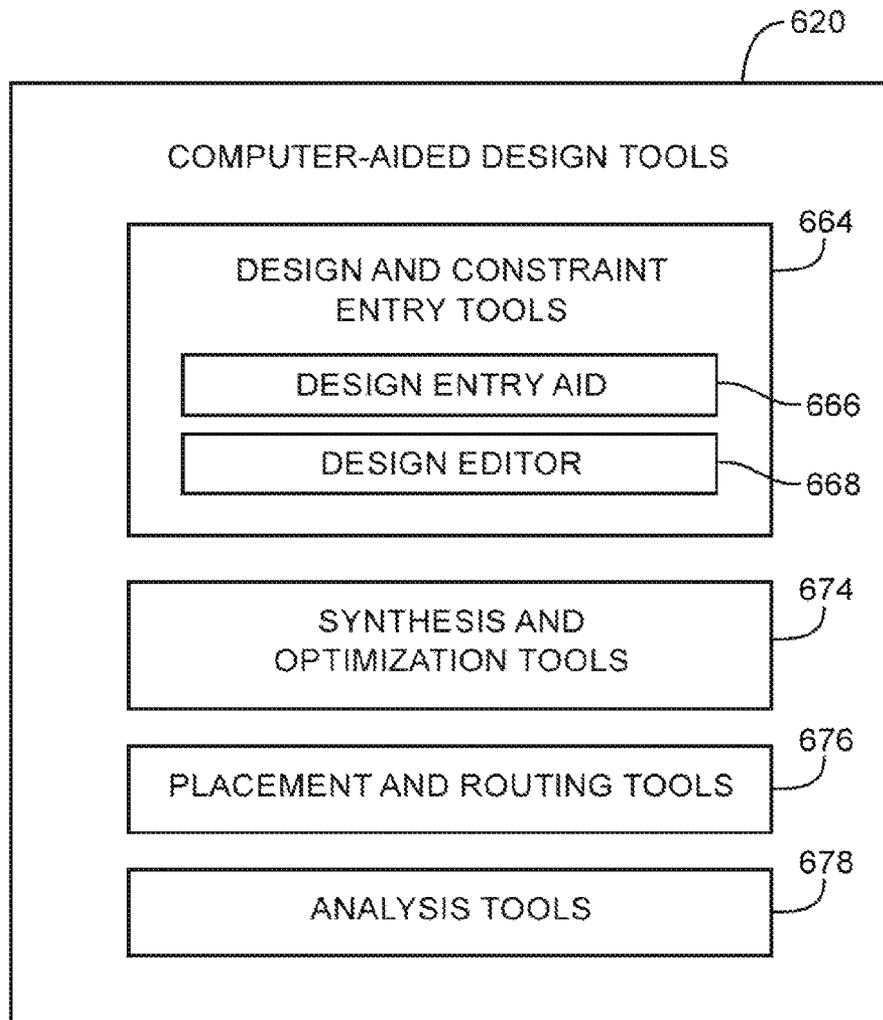


FIG. 13

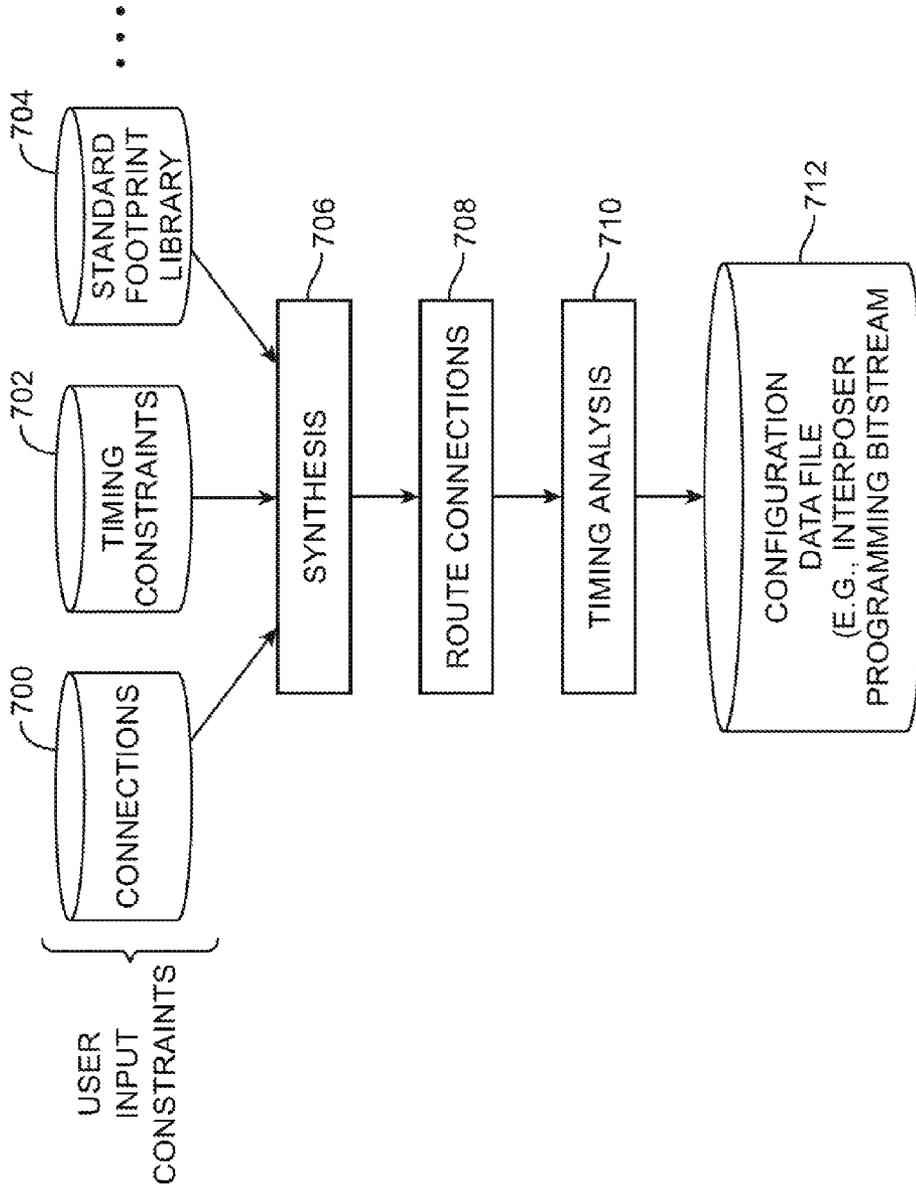


FIG. 14

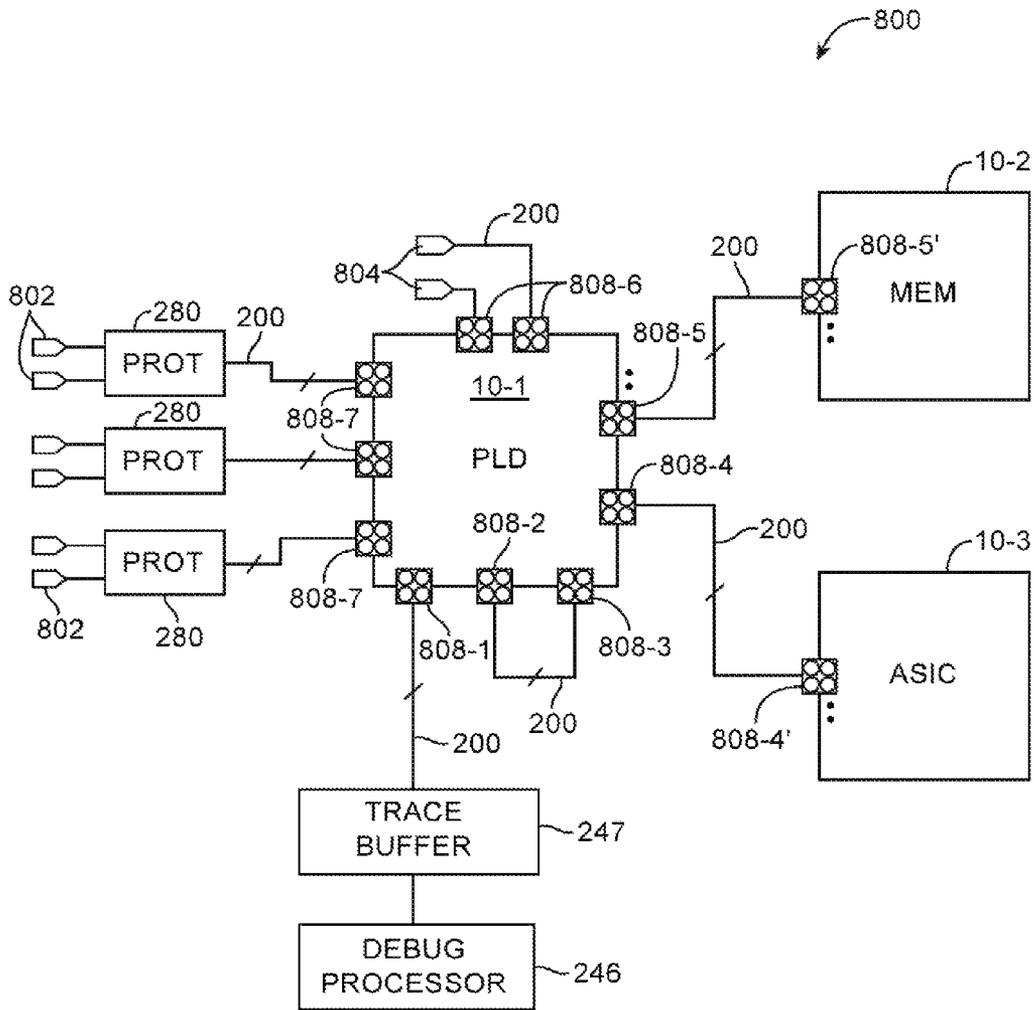


FIG. 15

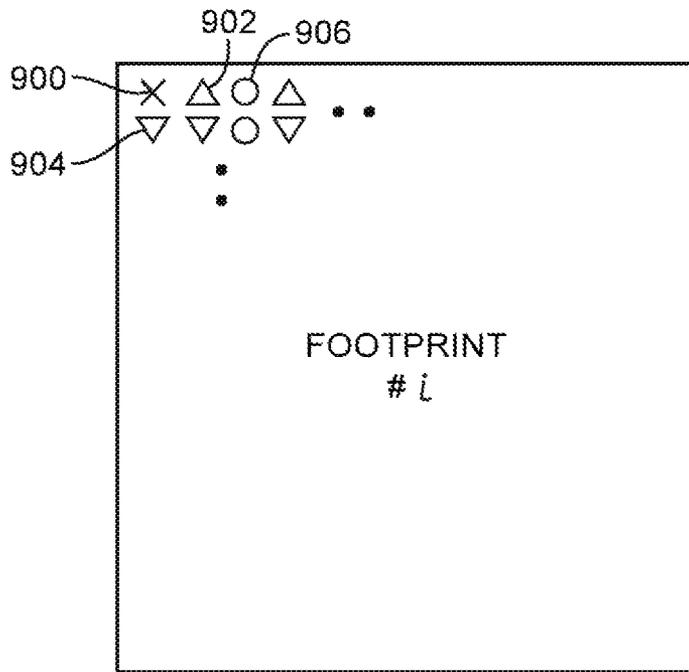


FIG. 16

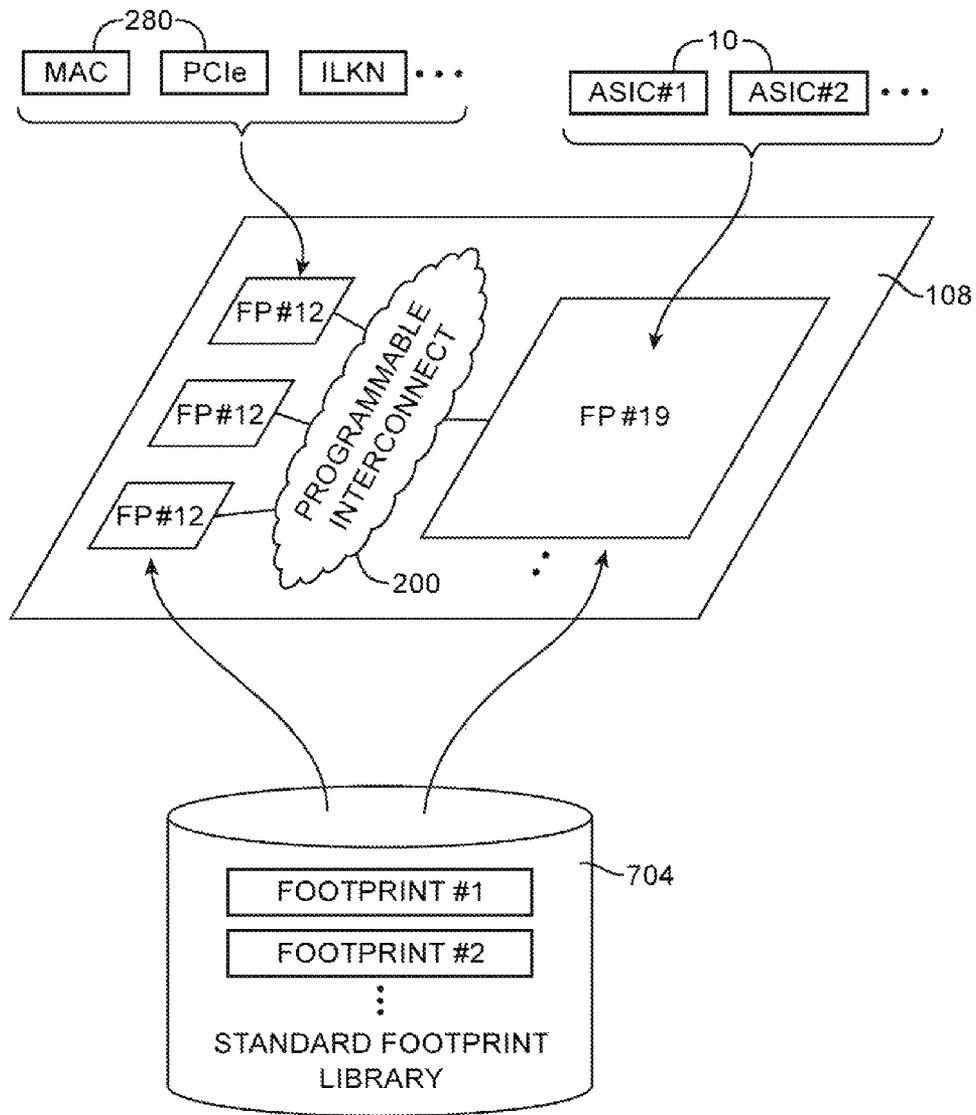


FIG. 17

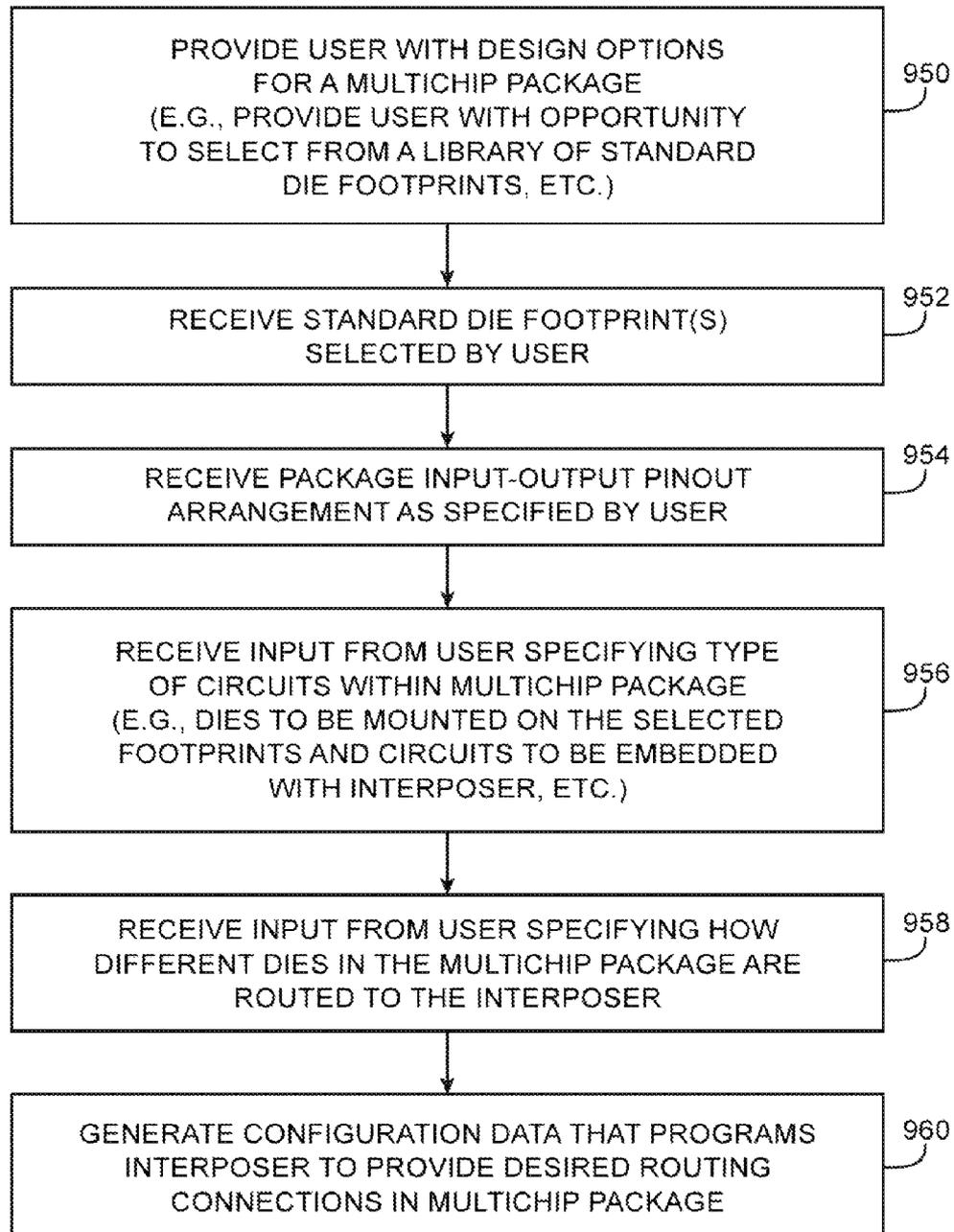


FIG. 18

PROGRAMMABLE INTERPOSER CIRCUITRY

BACKGROUND

An integrated circuit package generally includes, among others, an integrated circuit die and a substrate on which the die is mounted. The die is typically coupled to the substrate through wires or solder bumps. Signals from the integrated circuit die may then travel through the wires or solder bumps to the substrate.

As integrated circuit technology scales towards smaller device dimensions, device performance continues to improve at the expense of increased power consumption. In an effort to reduce power consumption, more than one die may be placed within a single integrated circuit package (i.e., a multichip package). As different types of devices cater to different types of applications, more dies may be required in some systems to meet the requirements of high performance applications. Accordingly, to obtain better performance and higher density, an integrated circuit package may include multiple dies arranged laterally along the same plane or may include multiple dies stacked on top of one another.

Multichip packages have been developed that include multiple dies mounted on top of a silicon interposer. The silicon interposer typically includes fixed connections that connect one die to another in a multichip package. Because the connections are fixed, it is oftentimes challenging to design the silicon interposer that has to be able to interface with different types of dies that are oftentimes manufactured by multiple parties with different timelines.

SUMMARY

This relates generally to multichip packages and, more particularly, to multichip packages with configurable interposer integrated circuit devices. Multiple integrated circuit dies may be mounted on top of the interposer within the housing of the multichip package. The interposer may be mounted on top of a package substrate. If desired, multiple interposers may be stacked vertically with respect to one another.

Microbumps may be interposed between the interposer and the on-interposer dies, whereas flip-chip bumps (e.g., bumps that are relatively larger than the microbumps) may be interposed between the interposer and the package substrate. The interposer may include input-output pins configured to interface with the on-interposer integrated circuit dies via the microbumps. The interposer may include programmable interconnect circuitry (sometimes referred to as programmable interconnect routing fabric) that serves to provide desired routing connections for the on-interposer integrated circuit dies.

The programmable interconnect circuitry may include vertical and horizontal routing paths, configurable multiplexers that are interposed in the routing paths, configuration memory elements that store control bits for controlling the configurable multiplexers, and a configuration controller that is used to load the control bits into the configuration memory elements. The programmable interconnect circuitry may include paths for connecting different on-interposer dies, paths for self-routing (e.g., paths that are coupled between input-output pins associated with a single on-interposer die), and paths for connecting the on-interposer dies to off-interposer devices.

Active circuitry may optionally be embedded as an integral part of the interposer. As an example, debug circuitry may be

embedded in the interposer for debugging various on-interposer dies. As another example, various interface circuits that implement desired input-output communications protocols may be embedded in the interposer.

In another suitable embodiment of the present invention, a method for designing a multichip package using computer-aided design (CAD) tools implemented on computing equipment is provided. The CAD tools may include a schematic capture tool that assists a circuit designer in designing a multichip package having a configurable interposer. The schematic capture tool may allow a user an opportunity to specify different intellectual property (IP) blocks (e.g., programmable integrated circuits, application specific integrated circuits, memory devices, network processing units, debugging circuitry etc.) to be placed within a multichip package, to select from a library of standardized die footprints (e.g., a library that contains standard interface formats each of which specifies a respective predetermined input-output pinout arrangement for a family of dies), and to make desired routing connections between the selected die footprints.

The CAD tools may then be used to perform circuit synthesis, physical routing, and timing analysis and may generate a corresponding configuration data file that includes data for configuring the programmable interconnect circuitry so that the programmable interconnect circuitry provides the desired interposer routing connections.

Further features of the present invention, its nature and various advantages will be more apparent from the accompanying drawings and the following detailed description.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a diagram of an illustrative programmable integrated circuit in accordance with an embodiment of the present invention.

FIG. 2 is a cross-sectional side view of an illustrative multichip package having at least two dies that are arranged laterally on top of a programmable interposer in accordance with an embodiment of the present invention.

FIG. 3 is a diagram of an illustrative programmable interposer integrated circuit in accordance with an embodiment of the present invention.

FIG. 4 is a cross-sectional side view of an illustrative multichip package that includes multiple programmable interposers stacked vertically with respect one another in accordance with an embodiment of the present invention.

FIG. 5 is a cross-sectional side view of a programmable interposer illustrating different types of routing connections that can be made in the programmable interposer in accordance with an embodiment of the present invention.

FIG. 6 is a diagram showing how a programmable interposer may be used to provide additional routing for an integrated circuit for debugging purposes in accordance with an embodiment of the present invention.

FIG. 7A is a diagram showing how an integrated circuit may be routed to a separate debug processor both of which are mounted on a programmable interposer in accordance with an embodiment of the present invention.

FIG. 7B is a diagram showing how an integrated circuit that is mounted on a programmable interposer may be routed to a debug processor that is embedded in the programmable interposer in accordance with an embodiment of the present invention.

FIG. 7C is a diagram showing how an integrated circuit that is mounted on a programmable interposer may be routed to an off-interposer PCB-resident debug processor in accordance with an embodiment of the present invention.

FIG. 8 is a diagram showing how an integrated circuit that is mounted on a programmable interposer may be routed to a trace buffer for check pointing in accordance with an embodiment of the present invention.

FIG. 9 is a diagram illustrating how integrated circuits on a programmable interposer may be routed to different types of communications devices that implement different communications protocols in accordance with an embodiment of the present invention.

FIGS. 10A and 10B are diagrams illustrating a programmable interposer that includes embedded communications devices that implement different communications protocols in accordance with an embodiment of the present invention.

FIG. 11 is a diagram of an illustrative system environment in which a programmable interposer integrated circuit may be configured using a circuit design system in accordance with an embodiment of the present invention.

FIG. 12 is a diagram of a circuit design system for generating configuration data for implementing custom routing designs in programmable interposer integrated circuits in accordance with an embodiment of the present invention.

FIG. 13 is a diagram of illustrative computer-aided design (CAD) tools that may be used in a circuit design system in accordance with an embodiment of the present invention.

FIG. 14 is a flow chart of illustrative steps for designing a custom interposer integrated circuit and performing timing analysis in accordance with an embodiment of the present invention.

FIG. 15 is an illustrative schematic input screen that may be presented to provide a user with an opportunity to pull standardized die footprints from a predefined library, to make connections between different devices, to specify package pin placement, and to set other desired settings in accordance with an embodiment of the present invention.

FIG. 16 is a diagram of an illustrative standardized pinout footprint in accordance with an embodiment of the present invention.

FIG. 17 is a diagram illustrating how standard footprints that are selected from a predefined library for use on a programmable interposer integrated circuit are capable of interfacing with corresponding families of devices in accordance with an embodiment of the present invention.

FIG. 18 is a flow chart of illustrative steps for designing a programmable interposer in accordance with an embodiment of the present invention.

DETAILED DESCRIPTION

Embodiments of the present invention relate to integrated circuits, and more particularly, to multichip packages that include a plurality of integrated circuits. It will be recognized by one skilled in the art, that the present exemplary embodiments may be practiced without some or all of these specific details. In other instances, well-known operations have not been described in detail in order not to unnecessarily obscure the present embodiments.

An illustrative integrated circuit of the type that may be provided with memory elements and associated circuits that can be controlled using output signals from the memory elements is shown in FIG. 1. As shown in FIG. 1, integrated circuit 10 may contain memory elements 20. Memory elements 20 may be loaded with configuration data to configure programmable transistors such as pass transistors (sometimes referred to as pass gates or pass gate transistors) in programmable circuitry such as programmable logic 18.

Because memory elements 20 may be used in storing configuration data for programmable logic 18, memory elements

20 may sometimes be referred to as configuration random-access memory (CRAM) cells. Integrated circuit 10 may be configured to implement custom logic functions by configuring programmable logic 18. As a result, integrated circuit 10 may sometimes be referred to as a programmable integrated circuit or a programmable logic device (PLD) integrated circuit.

As shown in FIG. 1, programmable integrated circuit 10 may have input-output (I/O) circuitry 12 for driving signals off of device 10 and for receiving signals from other devices via input-output pins 14. Interconnection resources 16 such as global and local vertical and horizontal conductive lines and buses may be used to route signals on device 10. Interconnection resources 16 may include fixed interconnects (conductive lines) and programmable interconnects (i.e., programmable connections between respective fixed interconnects).

Programmable logic 18 may include combinational and sequential logic circuitry. Programmable logic 18 may be configured to perform a custom logic function. The programmable interconnects associated with interconnection resources 16 may be considered to form a part of programmable logic 18.

When memory elements 20 are loaded with configuration data, the memory elements each provide a corresponding static control output signal that controls the state of an associated logic component in programmable logic 18. The memory element output signals may, for example, be used to control the gates of metal-oxide-semiconductor (MOS) transistors such as n-channel metal-oxide-semiconductor (NMOS) pass transistors in programmable components such as multiplexers, logic gates such as AND gates, OR gates, XOR gates, NAND gates, NOR gates, etc. P-channel transistors (e.g., a p-channel metal-oxide-semiconductor pass transistor) may also be controlled by output signals from memory elements 20, if desired.

When a memory element output that is associated with an NMOS pass transistor is high, the pass transistor controlled by that memory element is turned on and passes logic signals from its input to its output. When the memory element output is low, an NMOS pass transistor is turned off and does not pass logic signals. P-channel metal-oxide-semiconductor (PMOS) pass transistors are turned on when the signal that is applied to its gate from the output of a memory element is low (e.g., 0 volts) and are turned off when the output of the memory element is high (i.e., the polarity for NMOS and PMOS control signals is reversed).

Configuration random-access memory elements 20 may be arranged in an array pattern. There may be, for example, millions of memory elements 20 on integrated circuit 10. During programming operations, the array of memory elements is provided with configuration data. Once loaded with configuration data, memory elements 20 may selectively control (e.g., turn on and off) portions of the circuitry in the programmable logic 18 and thereby customize the circuit functions of circuit 10.

The circuitry of programmable integrated circuit 10 may be organized using any suitable architecture. As an example, the circuitry of programmable integrated circuit 10 may be organized in a series of rows and columns of programmable logic blocks (regions) each of which contains multiple smaller logic regions. The logic resources of integrated circuit 10 may be interconnected by interconnection resources 16 such as associated vertical and horizontal conductors. These conductors may include global conductive lines that span substantially all of device 10, fractional lines such as half-lines or quarter lines that span part of device 10, staggered

lines of a particular length (e.g., sufficient to interconnect several logic areas), smaller local lines, or any other suitable interconnection resource arrangement. If desired, the circuitry of programmable integrated circuit **10** may be arranged in more levels or layers in which multiple large regions are interconnected to form still larger portions of logic. Still other device arrangements may use logic that is not arranged in rows and columns.

As integrated circuit fabrication technology scales towards smaller process nodes, it becomes increasingly challenging to design an entire system on a single integrated circuit die (sometimes referred to as a system-on-chip). Designing analog and digital circuitry to support desired performance levels while minimizing leakage and power consumption can be extremely time consuming and costly.

One alternative to single-die packages is an arrangement in which multiple dies are placed within a single package. Such types of packages that contain multiple interconnected dies may sometimes be referred to as systems-in-package (SiPs), multichip modules (MCM), or multichip packages. Placing multiple chips (dies) into a single package may allow each die to be implemented using the most appropriate technology process (e.g., a memory chip may be implemented using the 28 nm technology node, whereas the radio-frequency analog chip may be implemented using the 90 nm technology node), may increase the performance of die-to-die interface (e.g., driving signals from one die to another within a single package is substantially easier than driving signals from one package to another, thereby reducing power consumption of associated input-output buffers), may free up input-output pins (e.g., input-output pins associated with die-to-die connections are much smaller than pins associated with package-to-board connections), and may help simplify printed circuit board (PCB) design (i.e., the design of the PCB on which the multichip package is mounted during normal system operation).

FIG. 2 is a cross-sectional side view of an illustrative multichip package **100**. As shown in FIG. 2, multichip package **100** may include a package substrate such as package substrate **122**, interposer **108** that is mounted on top of package substrate **122**, and multiple dies mounted on top of interposer **108** (e.g., dies **10-1** and **10-2** may be mounted laterally with respect to each other on top of interposer **108**).

Package substrate **122** may be coupled to board substrate **126** via solder balls **124**. As an example, solder balls **124** may form a ball grid array (BGA) configuration for interfacing with corresponding conductive pads on substrate **126**. Substrate **126** may be a printed circuit board (PCB) on which multichip package **100** and other single-chip or multichip packages may be mounted. The exemplary configuration of FIG. 2 in which two laterally positioned dies are interconnected via an interposer structure **108** may sometimes be referred to as 2.5-dimensional (“2.5D”) stacking. If desired, more than two laterally (horizontally) positioned dies may be mounted on top of interposer structure **108**. In other suitable arrangements, multiple dies may be stacked vertically on top of one another. In general, multichip package may include any number of dies stacked on top of one another and dies arranged laterally with respect to one another.

Each die **10** (i.e., dies **10-1** and **10-2**) may include a semiconductor substrate **130** (e.g., a p-type silicon substrate) having a first surface **150**, a second surface **152**, and interconnect layers **132** formed on the first surface **150** of substrate **130**. Device structures such as transistor gate structures, capacitor plate structures, resistive load structures, density-compliance structures, and other device structures may be formed at the interface where interconnect layers **132** meet surface **150**.

Interconnect layers **132** (sometimes referred to collectively as a dielectric stack) may include alternating layers of metal routing layers (e.g., dielectric layers in which metal routing paths can be formed) and via layers (e.g., dielectric layers through which metal vias can be formed for electrically connecting paths from one metal routing layer to paths in another metal routing layer).

Surface **150** on which interconnect layers **132** are formed is typically referred to as the “upper” surface of substrate **130**. The configuration as shown in FIG. 2 in which surface **150** is facing downwards towards package substrate **122** is therefore sometimes referred to as a flip-chip configuration, because each die **10** is inverted/flipped from its upright orientation.

Dies **10-1** and **10-2** may be coupled to interposer **108** via microbumps **134**. Microbumps **134** may refer to solder bumps that are formed on the uppermost layer of interconnect stack **132** and may each have a diameter of 10 μm (as an example). In particular, microbumps **134** may be deposited on microbump pads that are formed in the uppermost layer of interconnect stack **132**.

Interposer **108** may be coupled to package substrate **122** via bumps **120**. Bumps **120** that interface directly with package substrate **122** may sometimes be referred to as controlled collapse chip connection (C4) bumps or “flip-chip” bumps and may each have a diameter of 100 μm (as an example). Generally, flip-chip bumps **120** (e.g., bumps used for interfacing with off-package components) are substantially larger in size compared to microbumps **134** (e.g., bumps used for interfacing with other dies within the same package). The number of microbumps **134** is typically much greater than the number of flip-chip bumps **120** (e.g., the ratio of the number of microbumps to the number of flip-chip bumps may be greater than 2:1, 5:1, 10:1, etc.).

As shown in FIG. 2, interposer **108** may include programmable interconnect circuitry **200** that is used to form routing connections to each die **10** that is mounted on top of interposer **108** via microbumps **134** and to form routing connections to other devices on package substrate **122** or board substrate **126** via flip-chip bumps **120**. Programmable interconnect circuitry **200** may include fixed and/or configurable interconnection resources such as global and local vertical and horizontal conductive lines and buses for routing signals through interposer **108**. The global conductive lines may span substantially all of interposer **108**, whereas the local conductive lines may span only part of interposer **108**.

In one suitable arrangement, interposer **108** may be formed from silicon (e.g., interconnect circuitry **200** may be formed in a silicon substrate). Silicon interposer **108** may include programmable resources such as the programmable circuitry that is included in programmable integrated circuit **10** of the type described in connection with FIG. 1, except interposer **108** need not include any combinational or sequential logic (e.g., interposer **108** need not include circuitry for performing user-defined logic functions). Interposer **108** of this type may include circuitry such as circuitry **200** that is primarily used for providing desired routing connections for dies **10** within multichip package **100**. If desired, however, interposer **108** may contain some logic for implementing interface functionality for facilitating communications between different dies in package **100** and for performing other desired functions for the on-interposer devices. Offloading some of these functions from the on-interposer devices to interposer-embedded logic can help reduce processing requirements for the on-interposer devices.

Interposer **108** formed and operated in this way may sometimes be referred to as a configurable silicon interposer integrated circuit, a programmable interposer PCB on a chip, a

programmable interposer card, a programmable “fabric” interposer, an “active” programmable interposer (e.g., an interposer that contains embedded logic for facilitating desired operations for dies within package 100), etc. In general, any type of bare-die integrated circuit 10 may be mounted on top of interposer 108, including but not limited to devices such as microprocessors (or CPUs), digital signal processors (DSPs), application specific standard products (ASSPs), application specific integrated circuits (ASICs), static random-access memory (SRAM) chips, dynamic random-access memory (DRAM) chips, read-only memory (ROM) chips, programmable array logic (PAL), programmable logic arrays (PLAs), field programmable logic arrays (FPLAs), electrically programmable logic devices (EPLDs), electrically erasable programmable logic devices (EEPROMs), logic cell arrays (LCAs), field programmable gate arrays (FPGAs), just to name a few.

FIG. 3 shows a more detailed diagram of configurable interposer 108. As shown in FIG. 3, interposer 108 may include, in addition to programmable interconnect circuitry 200, a configuration controller 202, memory elements 204, microbump interface circuitry 206, and flip-chip bump interface circuitry 208. In the example of FIG. 3, programmable interconnect circuitry 200 includes a collection of horizontal and vertical wires that are connected by programmable fabric such as routing multiplexing circuits (e.g., multiplexers) 214. In general, interposer 108 may include hundreds, thousands, or millions of multiplexers 216 that can be configured to provide any suitable routing arrangement. Each routing multiplexer 214 may have inputs some of which receive signals from various vertical wires 210 and some of which receive signals from various horizontal wires 212, a control input, and an output on which a corresponding signal may be routed from one of its inputs.

Horizontal interconnects 212 and vertical interconnects 210 may be formed with varying lengths depending on the distance that each conductor spans. Each multiplexer 214 may be coupled to an associated driver circuit 216 that is used for driving the output signal onto a corresponding horizontal conductor 212 or vertical conductor 210. Driver 216 may drive signals onto the interconnects with an appropriate drive strength based on the lengths of the interconnects and/or other physical characteristics of the interconnects. For example, a first driver 216 may drive a first interconnect conductor with a higher drive strength than a second driver 216 that drives a second interconnect conductor, because the first interconnect conductor has a greater resistance than the second interconnect conductor (e.g., because the first interconnect conductor spans a longer distance than the second interconnect conductor). However, it is appreciated that the drive strength may similarly vary based on the width of the interconnection as well.

Each routing multiplexer 214 may receive at its control input a respective set of configuration data bits for configuring that multiplexer 214 to route signals from a selected one of its inputs to its output. The configuration data bits may be provided from memory elements 204 over paths 218. Configuration controller 202 may be used to load the desired pattern of configuration data bits (sometimes referred to as a programming bitstream) into memory elements 204 to configure interconnect circuitry 200 with the desired routing arrangements. Configuration controller 202 may be implemented as a data register, a shift register, a state machine, or other types of circuitry that is suitable for loading the programming bitstream into memory elements 204.

Circuitry 206 may serve as an interface between dies 10 that are mounted on top of interposer 108 (sometimes referred

to as “on-interposer” dies) and programmable interconnect circuitry 200, whereas circuitry 208 may serve as an interface between interconnect circuitry 200 and package substrate 122. In general, programmable interconnect circuitry 200 may route signals via microbump interface 206 and flip-chip bump interface 208 in either direction (as indicated by path 220).

As an example, a signal that is received by interconnect circuitry 200 via interface 206 may be selectively routed to a corresponding flip-chip bump 120 via interface 208. As another example, a signal from a given die 10 that is received by interconnect circuitry 200 via interface 206 may be routed back through interface 206 to the given die 10 or another die that is mounted on interposer 108. As yet another example, a signal that is received by interconnect circuitry 200 via interface 208 may be selectively routed to a corresponding microbump 134 via interface 206. Other types of connectivity may also be provided by programming configurable interposer 108 with the desired settings. If desired, any portion of drivers 216 may be placed in tristate mode when an input-output path need not be actively driven.

In another suitable embodiment of the present invention, multiple interposers 108 may be stacked vertically on top of one another (see, e.g., FIG. 4). As shown in FIG. 4, interposer 108-2 may be stacked on top of interposer 108-1. In one embodiment, programmable interconnect circuitry 200 of interposer 108-1 may be selectively coupled to programmable interconnect circuitry 200 of interposer 108-2 via flip-chip (C4) bumps 120 that are interposed between interposers 108-1 and 108-2.

Integrated circuit dies may be mounted on top of each interposer 108-1 and 108-2. In the example of FIG. 4, dies 10-1, 10-2, and 10-3 may be mounted on top of interposer 108-1, whereas dies 10-4, 10-5, 10-6, 10-7, and 10-8 may be mounted on top of interposer 108-2. This type of configuration in which interposers are stacked vertically on top of one another may sometimes be referred to as “3D” stacking. In some scenarios, through-silicon vias (TSVs) may be formed through the silicon substrate of each interposer 108 in a 3D stack for allowing vertical connectivity. In certain embodiments, such TSVs can be used to provide connections between programmable interconnect circuitry located on two separate programmable interposers or between dies that are mounted on two separate programmable interposers. Such 3D stacking enables interconnectivity among dies that are mounted on separate programmable interposers, thereby facilitating the physical expansion of a system design.

The multichip package arrangements as shown in FIGS. 2 and 4 are merely illustrative and do not serve to limit the scope of the present invention. If desired, multichip package 100 may include any number of dies that are interconnected using one or more configurable interposers 108. In general, dies that are part of a multichip package 100 may be contained within a housing that is molded from plastic, resin, ceramic, or other suitable materials.

FIG. 5 is a cross-sectional side view of interposer 108 showing some of the different possible routing connections that can be made using programmable interconnect fabric 200. As shown in FIG. 5, programmable interconnect circuitry 200 may be used for routing signals between different dies that are mounted on an interposer 108 (e.g., die 10-1 may be coupled to die 10-2 via inter-die routing path 230). Programmable interconnect circuitry 200 may also be used for routing signals from one or more off-interposer devices (e.g., die 10-1 may be coupled to one or more existing vertically-stacked die and/or to one or more existing off-interposer devices via path 232 and flip-chip bump 120). This flexibility

in routing input-output pins of each die **10** to user-preferred flip-chip bumps **120** enables a system designer to select a preferred signal input-output placement which is optimized for the target PCB design on which the base interposer **108** is mounted. Such types of paths may also be used in sharing clock signals, reset signals, address signals, and other control signals among multiple different devices formed within multichip package **100**.

In some embodiments, programmable interconnect circuitry **200** may also be used for routing long-distance signals for an individual die. There may, for example, be tens of thousands of microbumps **134** formed at the interface between die **10-2** and interposer **108**. In most scenarios, only a portion of the microbumps **134** associated with a given die is used in forming connections with other on-interposer dies and off-interposer devices. The remaining portion of microbumps **134** may therefore be used to provide additional routing resources for that die (see, e.g., path **234** in FIG. 5). Performing "self-routing" in this way can help to reduce the complexity of routing resources that is required within the given die, thereby reducing cost.

In conventional single-chip packages, an integrated circuit is connected directly to the package substrate via flip-chip bumps. The number of flip-chip bumps interposed between the integrated circuit and the package substrate is typically on the order of a thousand. In multichip packages, however, the use of microbumps **134** between on-interposer dies and interposer **108** dramatically increases the number of interconnections that can be made. The number of microbumps **134** that can be formed between an integrated circuit and interposer **108** may be on the order of tens of thousands. This wide availability of input-output connections via microbumps may allow integrated circuits to perform some of its routing off-chip on the interposer. The self-routing technique described in connection with FIG. 5 is one example of how routing may be performed off-chip.

In another suitable arrangement of the present invention, user signals may be routed off-chip for debugging purposes. FIG. 6 illustrates an example in which user signals that are generated by logic circuits **240** in device **10** may be routed to debugging circuitry **242** that is also formed in device **10**. The user/test signals may be conveyed from circuits **240** to debug circuitry **242** via programmable self-route path **234** in interposer **108**. The programmable interconnect circuitry in interposer **108** used in this way may therefore serve as wide-bandwidth user debug pins.

FIG. 7A shows another suitable debugging configuration in which signals under test may be routed from logic circuits **240** on device **10** to a separate debug processor **246**. As shown in FIG. 7A, both device **10** and debug processor **246** are mounted on interposer **108**. The user signals under test may be conveyed from circuits **240** to processor **246** via programmable die-to-die routing path **244**.

FIG. 7B shows another suitable debugging configuration in which user signals under test may be routed from logic circuits **240** on device **10** to a debug processor **248** that is embedded within interposer **108**. In particular, debug processor **248** may be formed in the silicon substrate of interposer **108** (e.g., debug logic circuitry **248** may be formed as an integral part of configurable interposer **108**). The user signals under test may be conveyed from circuits **240** to processor **248** via programmable routing path **250**.

FIG. 7C shows another suitable debugging configuration in which user signals under test may be routed from logic circuits **240** on device **10** to an off-interposer PCB-resident debug microprocessor **252**. As shown in FIG. 7C, debug microprocessor **252** and die **10-2** in which logic circuits **240**

are formed may be formed on separate packages that are both mounted on PCB **126** (e.g., die **10-2** may be mounted on a first package substrate **122**, whereas debug processor **252** may be mounted on a second package substrate **123**). The user signals may be conveyed from circuits **240** to processor **252** via path **254**. At least a portion of path **254** that traverses interposer **108** may be programmable.

FIG. 8 is a top view of another suitable debugging configuration in which user/data signals may be routed from logic circuits **240** on device **10** to a separate debug processor **247** via a buffer circuit such as trace buffer **249**. In the example of FIG. 8, debug processor **247** may be another die that is mounted on top of interposer **108** (as described in connection with FIG. 7A) or may be embedded in interposer **108** (as described in connection with FIG. 7B). Trace buffer circuit **249** may serve as a first-in first-out (FIFO) circuit for temporarily storing user signals that are output from logic circuit **240**. When an error occurs on device **10**, device **10** may provide an asserted control signal ERROR to debug processor **247**. In response to detecting signal ERROR being asserted, debug processor **247** may retrieve the contents of trace buffer **249** to perform the necessary debugging operations. Performing debugging using this method may allow processor **247** to perform other system operations when signal ERROR is deasserted.

In another suitable embodiment of the present invention, configurable silicon interposer **108** may also be used in packet processing applications to facilitate communications based on select interconnect protocols. FIG. 9 is a diagram illustrating a scenario in which multichip package **100** is being used as a line card (e.g., a device that is used to interface with a telecommunications access network such as the Internet or a local area network).

As shown in FIG. 9, multichip package **100** may include a first integrated circuit die **10-1**, a second integrated circuit die **10-2**, and multiple communications devices **260** mounted on configurable silicon interposer **108**. Dies **10-1** and **10-2** may be any suitable type of integrated circuits. Die **10-1** may contain an input-output (I/O) interface **270** that is configured to communicate with I/O interface **272** of die **10-2** via programmable interconnect fabric **200** (as indicated by path **274**). Interface circuits **270** and **272** may be communications devices that implement the same communications protocol/standard. As an example, interface circuits **270** and **272** may both serve to implement the Peripheral Component Interconnect Express (PCIe) high-speed serial computer expansion bus standard.

Programmable interconnect fabric **200** on interposer **108** may be configured to couple at least one of integrated circuits **10** to a portion of communications devices **260**. In the example of FIG. 9, die **10-1** may be selectively coupled to three of the five communications devices **260** via programmable interconnect **200**. This is merely illustrative. Interposer **108** may be capable of interfacing on-interposer dies with more or less than five communications devices via interconnect circuitry **200**.

Each communications device **260** may be a transceiver integrated circuit that is capable of transmitting signals to and receiving signals from off-interposer devices via flip-chip bumps **120**. Each transceiver **260** may contain a communications interface circuit **262** that implements a desired communications protocol/standard. Transceiver **260** having interface **262** is sometimes referred to as a physical media interface device. Each interface circuit **262** may be configured to implement a selected one of the Ethernet protocol (e.g., the protocol for controlling the Media Access Control sublayer), the Interlaken interconnect protocol, the double data rate

(DDR) memory data transfer protocol, the PCIe bus standard, and/or other suitable input-output communications protocols.

Multichip package **100** formed in this way may be used to provide redundant capabilities. In the example of FIG. **9**, only three of the five interface devices are actively connected to packet processing chip **10-1**. Chip **10-1** may include an interface circuit **264** that is used to implement desired protocols for communicating with interface circuits **262**. In scenarios in which one of the three interface devices is faulty or defective, one of the remaining idle interface devices may be switched into use to replace the faulty interface device (e.g., by reprogramming interconnect circuitry **200**, as indicated by dashed arrow **266**). This application assumes that a portion of the interface devices are of the same type (e.g., a portion of the active and inactive interface devices should implement the same communications protocol in order to support redundancy).

In general, devices **260** may be communications devices of different types (i.e., the active and inactive interface devices may implement a variety of different communications protocols). Having different types of communications devices **260** allows multichip package **100** to support a variety of different technologies that are useful in targeting different domain-specific applications such as wireline applications, wireless applications, etc. If desired, communications devices **260** may themselves be reprogrammable to support a variety of possible network applications.

In certain domain-specific applications, it may be desirable to offload the protocol implementing interface circuits from transceiver integrated circuits **260** (see, e.g., FIG. **10A**). The protocol implement interface circuits such as interface circuitry **280** of FIG. **10A** may be embedded as non-reconfigurable or "hard" blocks (sometimes referred to as fixed-function blocks) in interposer **108**. As shown in FIG. **10A**, die **10-1** (e.g., a programmable integrated circuit such as an FPGA) may be coupled to die **10-2** (e.g., a memory chip contain SRAM cells) via programmable interposer interconnect **200** and may be coupled a selected portion of transceiver devices **260**. In the example of FIG. **10A**, two of the four transceiver devices **260** are coupled to die **10-1** via interposer-embedded media access controllers **280** (e.g., application specific interface circuits that are embedded in interposer **108** for supporting the Ethernet protocol) while another two of transceiver devices **260** are coupled to die **10-1** without being routed through the any media access controller **280**. The different MAC blocks **280** may be selectively switched into using programmable interconnect paths **200**.

The example of FIG. **10A** in which multichip package **100** is use to target Ethernet specific applications is merely illustrative. If desired, interposer **108** may include different types of embedded communications protocol interface blocks for addressing different technologies and applications.

FIG. **10B** is a cross-sectional side view of a multichip package **100** having an interposer **108** with different types of interposer-embedded communications protocol interface blocks **280** for addressing a wide variety of applications. In the example of FIG. **10B**, three different types of integrated circuits dies **10-1**, **10-2**, and **10-3** may be mounted on interposer **108**. Die **10-1** may be a programmable integrated circuit; die **10-2** may be a static random-access memory chip; and die **10-3** may be a synchronous dynamic random-access memory chip (as examples).

The different on-interposer dies **10** may be coupled to one another via programmable interposer interconnect circuitry **200** and may be coupled to bumps **120**. Some of dies **10** may be coupled to bumps **120** via interposer embedded communications interface blocks **280**. In the example of FIG. **10B**,

interposer **108** may include an embedded MAC block **280** for supporting the Ethernet protocol, an embedded ILKN block **280** for supporting the Interlaken interconnect protocol, and/or other interface blocks for handling other desired communications technologies.

An illustrative system environment for designing and configuring a configurable interposer integrated circuit device **108** is shown in FIG. **11**. During configuration operations, interposer **108** may be mounted on a board **360** in a system **380**. Interposer **108** may receive configuration data from programming equipment or from any other suitable equipment or device.

In the example of FIG. **11**, interposer **108** is a type of programmable integrated circuit that receives configuration data from an associated integrated circuit **400**. With this type of arrangement, circuit **400** may, if desired, be mounted on the same board **360** as interposer **108**. As an example, circuit **400** may be a programmable interconnect configuration data loading chip that interfaces with configuration controller **202** to load configuration data into interposer memory elements **204** (FIG. **3**). The configuration data may be used to configure programmable interconnect circuitry **200** in a desired routing arrangement, to configure logic circuitry within interposer **108** to implement desired input-output communications protocols, to configure logic circuitry within interposer **108** to serve as debugging circuits, etc. When system **380** boots up (or at another suitable time), the configuration data may be supplied to interposer **108** from device **400**, as shown schematically by path **420**. The configuration data that is supplied to device **108** may be stored in its programmable memory elements **204** (e.g., configuration random-access-memory elements).

System **380** may include processing circuits **440**, storage **460**, and other system components **480** that communicate with device **108**. The components of system **380** may be located on one or more boards such as board **360** or other suitable mounting structures or housings.

Communication paths may be used to interconnect device **108** to other components. For example, communication path **370** may be used to convey data between an integrated circuit **390** that is mounted on board **360** and device **108**. Communication paths **350** and **500** can be used to convey signals between device **108** and components **440**, **460**, and **480**.

Configuration device **400** may be supplied with the configuration data for device **108** over a path such as path **520**. Configuration device **400** may, for example, receive the configuration data from configuration data loading equipment **540** or other suitable equipment that stores the configuration data in configuration device **400**. Device **400** may be loaded with data before or after installation on board **360**.

It can be a significant undertaking to design and implement desired routing configurations on an interposer that has to interface with various types of integrated circuits. Designers therefore generally use design systems based on computer-aided-design (CAD) tools to assist them in designing such types of circuits. A circuit design system can help a system designer design and test complex circuits for a system. When a design is complete, the design system may be used to generate configuration data for electrically programming the appropriate routing connections for interposer **108**. The circuit design system may be implemented on computing equipment.

As shown in FIG. **11**, the configuration data produced by a circuit design system **560** may be provided to equipment **540** over a path such as path **580**. Equipment **540** provides the configuration data to device **400** so that device **400** can later provide this configuration data to device **108** over path **420**.

System **560** may be based on one or more computers and one or more software programs. In general, software and data may be stored on any computer-readable medium (storage) in system **560** and is shown schematically as storage **600**.

In a typical scenario, design system **560** is used by a circuit designer to create a custom routing design for interposer device **108**. The system **560** produces corresponding configuration data which is provided to configuration device **400**. Upon power-up, configuration device **400** and configuration controller **202** on device **108** is used to load the configuration data into the programmable memory elements **204** of device **108**. Device **108** may then be used in normal operation to provide the desired routing connections in a multichip package.

An illustrative circuit design system **560** in accordance with the present invention is shown in FIG. **12**. System **560** may be based on one or more processors such as personal computers, workstations, etc. The processor(s) may be linked using a network (e.g., a local or wide area network). Memory in these computers or external memory and storage devices such as internal and/or external hard disks may be used to store instructions and data.

Software-based components such as computer-aided design tools **620** and databases **630** reside on system **560**. During operation, executable software such as the software of computer aided design tools **620** runs on the processor(s) of system **560**. Databases **630** are used to store data for the operation of system **560**. In general, software and data may be stored on any computer-readable medium (storage) in system **560**. Such storage, which is shown schematically as storage **600** of FIG. **11**, may include computer memory chips, removable and fixed media such as hard disk drives, flash memory, compact discs (CDs), DVDs, other optical media, and floppy diskettes, tapes, or any other suitable memory or storage device(s). When the software of system **560** is installed, the storage **600** of system **560** has instructions and data that cause the computing equipment in system **560** to execute various methods (processes). When performing these processes, the computing equipment is configured to implement the functions of the logic design system.

The computer aided design (CAD) tools **620**, some or all of which are sometimes referred to collectively as a CAD tool, may be provided by a single vendor or multiple vendors. Tools **620** may be provided as one or more suites of tools (e.g., a compiler suite for performing tasks associated with implementing a circuit design in a programmable logic device) and/or as one or more separate software components (tools). Database(s) **630** may include one or more databases that are accessed only by a particular tool or tools and may include one or more shared databases. Shared databases may be accessed by multiple tools. For example, a first tool may store data for a second tool in a shared database. The second tool can access the shared database to retrieve the data stored by the first tool. This allows one tool to pass information to another tool. Tools may also pass information between each other without storing information in a shared database if desired.

In one suitable embodiment of the present invention, database(s) **630** may include library of existing designs such as a standard footprint library **704**. Library **704** may define a standard set of die footprints (i.e., a common set of interface formats). Such types of predetermined die footprints (sometimes referred to in the schematic representation as interface "pinout" templates) may refer to the location of different types of pins (e.g., power pins, ground pins, user pins, etc.).

FIG. **16** shows an exemplary die footprint #*i* illustrating one suitable pinout arrangement. In the example of FIG. **16**,

locations marked as "X" represent idle microbump connection points; locations marked as "Δ" represent positive power supply microbump connection points; locations marked as "∇" represent ground power supply microbump connection points; whereas locations marked as "0" represent data/user signal microbump connections points.

The library of standard pinouts may be published so that integrated circuit dies **10** that are potentially designed by different manufacturers (i.e., dies **10** that are intended to be used in a multichip package with interposer **108**) can conform to at least one of the published pinouts. Maintaining a library of predefined pinouts may allow for the generation of families of integrated circuits that are amenable to the same interposer **108** (e.g., so that families of die from one manufacturer or for one application can be combined with families of another). When designing an interposer in this way, a family of modular wireline processors with differing memory/buffer sizes can share the same floorplan format, different programmable integrated circuits can share the same floorplan format, different physical media interfaces (at least some of which are redundant) can share the same floorplan format, etc.

FIG. **17** illustrates an interposer **108** having a footprint #**19** that is coupled to multiple footprints #**12** via programmable interconnect circuitry **200**. Footprints #**19** and #**12** may be selected from standard footprint library **704**. In the example of FIG. **17**, footprint #**19** may represent a common pinout format that is capable of interfacing with a family of ASICs from a given manufacturer, whereas footprint #**12** may represent a common pinout format that is capable of interfacing with a family of protocol implementing interface circuits **280**.

As an example, microprocessors manufactured by Intel Corporation could share a common interface format in library **704**. As another example, programmable integrated circuits manufactured by Altera Corporation may share another common interface format in library **704**. As yet another example, network processing units (NPUs) manufactured by Broadcom Corporation, EZChip Semiconductor, and NETRONOME may share yet another common interface format in library **704**. The use of standard footprint library **704** may simplify the design of multichip package systems by reducing the need for a new interposer device to be designed for every combination of die within a multichip package (e.g., the use of common interface formats can help facilitate the design of a multichip package when the multichip package includes chips from multiple manufacturers).

Illustrative computer aided design tools **620** that may be used in a logic design system such as system **560** of FIGS. **11** and **12** are shown in FIG. **13**. The design process typically starts with the formulation of routing specifications. A circuit designer can specify the connections that interposer **108** needs to make using design and constraint entry tools **664**. Design and constraint entry tools **664** may include tools such as design and constraint entry aid **666** and design editor **668**. Design and constraint entry aids such as aid **666** may be used to help a circuit designer locate a desired design from a library of existing designs (e.g., from standard footprint library **704**) and may provide computer-aided assistance to the circuit designer for entering (specifying) the desired design for interposer **108**.

As an example, design and constraint entry aid **666** may be used to present screens of options for a user. The user may click on on-screen options to select whether the circuit being designed should have certain features. Design editor **668** may be used to enter a design (e.g., by entering lines of hardware description language code), may be used to edit a design obtained from a library (e.g., using a design and constraint

entry aid), or may assist a user in selecting and editing appropriate prepackaged code/designs.

After the design has been entered using design and constraint entry tools **664**, synthesis and optimization tools **674** may be used to implement the specified routing connections using the programmable interconnect circuitry **200** in interposer **108**. Tools **674** may attempt to optimize the design by making appropriate selections of hardware to implement efficient allocation of routing resources based on user constraint data entered by the circuit designer using tools **664**.

After circuit synthesis and optimization using tools **674**, design system **560** may use tools such as placement and routing tools **676** to perform physical design steps (layout synthesis operations). Placement and routing tools **676** are used to determine how to physically realize the specified routing connections within the interposer device. Connections should be made to reduce interconnect delays or to satisfy timing requirements specifying the maximum permitted interconnect delay. The placement and routing tools **676** create orderly and efficient implementations of routing designs for a given interposer device.

Tools such as tools **674** and **676** may be part of a compiler suite (e.g., part of a suite of compiler tools provided by a configurable interposer device vendor). In accordance with the present invention, tools such as tools **674**, **676**, and **678** automatically take into account the effects of crosstalk between interconnects while implementing a desired circuit design. Tools **674**, **676**, and **678** may also include timing analysis tools. This allows tools **674** and **676** to satisfy performance requirements (e.g., timing requirements) when generating configuration data for programming integrated circuits such as programmable interposer integrated circuit **108**.

After an implementation of the desired routing design for interposer **108** has been generated using placement and routing tools **676**, the implementation of the design may be analyzed and tested using analysis tools **678**. After satisfactory optimization operations have been completed using tools **620**, tools **620** can produce the configuration data for the programmable logic device.

Illustrative operations involved in using tools **620** of FIG. **13** to produce configuration data files are shown in FIG. **14**. At step **706**, synthesis tools **674** may receive user input constraints such as a description of the desired routing connections **700**, timing constraints **702** specifying the performance criteria for interposer **108**, footprint designs selected from a standard footprint library **704**, and other suitable input settings to produce a post-synthesis netlist.

At step **708**, the post synthesis netlist is processed during place and route and optimization operations using tools **676**. During the operations of step **708**, the CAD tools **620** may take into account the effects of using different positive power supply voltages and/or body bias voltages and, through appropriate selection of power supply and body bias levels, circuit resource assignments, and placement decisions, reduce power consumption while satisfying design constraints.

At step **710**, a resulting final netlist may be processed further by performing a timing analysis using tools **678**. The timing analysis may be used to help ensure that the final netlist satisfies timing constraints. If desired, processing may optionally loop back to step **708** to perform additional optimizations using the final netlist. For example, design system **560** may identify routing paths in the final netlist that fail timing constraints and determine replacement routing paths by returning to step **708**.

The final netlist may be processed further during an assembly process to produce a configuration data file output **712** (e.g., a .pof or .sof file). The configuration data file output may then be loaded onto interposer **108** using circuitry of the type that is described in connection with FIG. **11**.

In another embodiment of the present invention, design and constraint entry tools **664** may include a schematic capture tool that can be used to specify the desired circuit connections **700**. A schematic capture tool may allow the circuit designer to visually construct different parts of a multichip package. FIG. **15** shows an illustrative schematic view of a multichip package system **800** that can be displayed to the circuit designer with the schematic capture tool. As shown in FIG. **15**, system **800** may include a first integrated circuit die **10-1** (e.g., a programmable logic device integrated circuit die), a second integrated circuit die **10-2** (e.g., a memory device), and a third integrated circuit die **10-3** (e.g., an application specific integrated circuit die such as a network processing unit). Dies **10-1**, **10-2**, and **10-3** may be mounted on configurable interposer **108** that is being designed using the schematic capture tool.

In the example of FIG. **15**, die **10-1** may interface with interposer **108** via footprints **808-1**, **808-2**, **808-3**, **808-4**, **808-5**, **808-6**, and **808-7** (e.g., a single die may interface with interposer **108** using a set of multiple standard die footprints). Footprints **808-1**, **808-2**, **808-3**, **808-4**, **808-5**, **808-6**, and **808-7** may be selected from the standard footprints library **704** (as an example).

Input-output pins associated with footprint **808-1** may be coupled to debug processor **246** via trace buffer **247** using interposer programmable interconnect paths **200**.

Processor **246** and buffer **247** may be embedded in interposer **108**, as described in connection with FIG. **8**. Input-output pins associated with footprints **808-2** and **808-3** may be used for self-routing connections. Input-output pins associated with footprint **808-4** may be coupled to die **10-3** via corresponding standard footprint **808-4'** using programmable interconnect paths **200** (e.g., die **10-3** may interface with interposer **108** via footprint **808-4'**). Input-output pins associated with footprint **808-5** may be coupled to die **10-2** via corresponding standard footprint **808-5'** using programmable interconnect paths **200** (e.g., die **10-2** may interface with interposer **108** using footprint **808-5'**). Input-output pins associated with footprints **808-6** may be used to interact directly with off-interposer devices via pins **804**. Input-output pins associated with footprints **808-7** may be used to communicate with off-interposer networking devices via protocol-implementing interface circuits **280** and pins **802**. Interface circuits **280** may be configured to implement desired communications protocol(s) and may be embedded in interposer **108** (as an example).

The different processing blocks such as blocks representing dies **10-1**, **10-2**, and **10-3**, debug circuitry **246-247**, and input-output interface circuits **280** may represent intellectual property (IP) blocks that are imported into the schematic capture tool (as part of an IP library that can be stored in database(s) **630**) for use in designing an interposer that has to interact with these different IP blocks.

In general, footprints **808** represent pinout arrangements for the microbump interface between interposer **108** and on-interposer devices, whereas pins **802** and **804** represent pinout arrangements for the flip-chip bump interface between interposer **108** and the package substrate. The schematic capture tool of this type may therefore be used to specify the desired interposer routing connections that should be made using the programmable interposer interconnect fabric. This schematic description may be translated into an initial netlist

and provided to tools **674** for synthesis. A schematic capture tool of this type may enable the system designer to experiment with various device floorplans and make desired connections between different components (in software) so as to enhance system performance.

System **800** of FIG. **15** is merely illustrative. A schematic capture tool configured in this way may enable a system designer to experiment with various device floorplans (in software) so as to optimize system performance. If desired, the schematic capture tool may be used to design an interposer that includes any number of on-interposer devices, interposer-embedded devices, and other suitable circuitry that are interconnected via standardized footprints using programmable interconnect circuitry **200** on the interposer.

FIG. **18** is a flow chart of illustrative steps involved in designing programmable interposer **108** using computer-aided design tools **620**. At step **950**, tools **620** may provide a system user with options for designing multichip package **100**. For example, the user may be provided with an opportunity to select from a library of standard die footprints that serve as an interface between interposer **108** and multiple dies **10** that are housed within package **100**.

At step **952**, tools **620** may receive at least one standard die footprint that has been selected by the user. The selected die footprint may specify a corresponding predetermined input-output pinout arrangement for a family of integrated circuit devices.

At step **954**, tools **620** may receive input from the user that specifies input-output pins for the multichip package (e.g., user input that specifies the package pinout to the PCB).

At step **956**, tools **620** may receive input from the user that specifies the type of circuits to be included within package **100** (e.g., the type of dies to be mounted on each of the selected die footprints, the type of circuits that are embedded within interposer **108**, etc.).

At step **958**, tools **620** may receive input from the user that specifies how the different dies in package **100** are routed to interposer **108**. In general, user input obtained during steps **952**, **954**, **956**, and **958** may be received in any suitable order.

At step **960**, tools **620** may generate configuration data for configuring programmable interposer **108** so that interposer **108** provides the desired routing connections for the multiple integrated circuit dies within package **100**. Such routing connections can include routing connections between the different on-interposer dies **10**, routing connections between one or more on-interposer dies **10** and package pins **124**, and routing connections between one or more on-interposer dies **10** and interposer-embedded circuits. In certain embodiments, the routing connections may include a direct wired connection (without any intervening switches), a connection through one or more buffers embedded within interposer **108** (e.g., buffer circuits for driving signals between different on-interposer dies and for driving signals between the on-interposer dies and the package pins), and a connection routed through one or more non-configurable blocks embedded within interposer **108**.

The use of a programmable interposer device designed in this way may enable maximum integration of multiple, different integrated circuit dies for optimum PCB footprint conservation. This is particularly desirably when different integrated circuit designs are scaled across multiple stacked (or 3D) interposers in a single system. In other words, the use of a programmable interposer may promote a best-fit PCB system interconnect, as the programmable interposer provides an abstraction layer from the actual die I/O pin assignments.

The use of a programmable interconnect also allows the system user freely re-route the microbump pads to the PCB

bonding pads as appropriate. This enables the programmable interposer to accommodate multiple integrated circuit dies each with unique power/ground pinout requirements and enables dies manufactured using various process geometries to coexist. Moreover, the use of microbumps for interfacing with the different dies in a multichip package facilitates a high-density/high-integrity inter-device signal interconnect solution. For example, high-density microbump interconnects may enable higher bandwidth signaling that would not otherwise have been possible on a standard PCB implementation lacking an interposer structure.

Although the methods of operations were described in a specific order, it should be understood that other operations may be performed in between described operations, described operations may be adjusted so that they occur at slightly different times or described operations may be distributed in a system which allows occurrence of the processing operations at various intervals associated with the processing, as long as the processing of the overlay operations are performed in a desired way.

The foregoing is merely illustrative of the principles of this invention and various modifications can be made by those skilled in the art without departing from the scope and spirit of the invention. The foregoing embodiments may be implemented individually or in any combination.

What is claimed is:

1. An interposer integrated circuit, comprising:

a plurality of input-output pins that interfaces with a plurality of integrated circuits which are mounted on the interposer integrated circuit; and
programmable interconnect circuitry that is coupled to the plurality of input-output pins and that serves to provide routing connections for the plurality of integrated circuits.

2. The interposer integrated circuit defined in claim 1, wherein at least a portion of the plurality input-output pins is coupled to the plurality of integrated circuits via microbumps.

3. The interposer integrated circuit defined in claim 2, wherein at least another portion of the plurality of input-output pins is coupled to flip-chip bumps, and wherein the flip-chip bumps are larger than the microbumps.

4. The interposer integrated circuit defined in claim 1, wherein the programmable interconnect circuitry comprises a plurality of routing paths and a plurality of configurable multiplexing circuits interposed in the plurality of routing paths.

5. The interposer integrated circuit defined in claim 4, further comprising:

a plurality of memory elements that stores configuration data bits for controlling the plurality of configurable multiplexing circuits.

6. The interposer integrated circuit defined in claim 5, further comprising:

a configuration controller that loads the configuration data bits into the plurality of memory elements.

7. The interposer integrated circuit defined in claim 1, wherein the programmable interconnect circuitry includes at least one self-routing path coupled between input-output pins associated with a selected one of the plurality of integrated circuits.

8. The interposer integrated circuit defined in claim 1, further comprising:

active processing circuitry embedded as an integral part of the interposer integrated circuit.

9. The interposer integrated circuit defined in claim 8, wherein the active processing circuitry comprises a debug processor.

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10. The interposer integrated circuit defined in claim 8, wherein the active processing circuitry includes an interface circuit configured to implement an input-output communications protocol.

11. A multichip package, comprising:

a package housing;

a plurality of integrated circuits in the package housing; and

a configurable interposer on which the plurality of integrated circuits are mounted, wherein the configurable interposer includes programmable interconnect routing circuitry that serves to perform signal routing for the plurality of integrated circuits.

12. The multichip package defined in claim 11, further comprising:

a package substrate on which the configurable interposer is mounted;

a plurality of flip-chip bumps interposed between the configurable interposer and the package substrate; and

a plurality of microbumps interposed between the configurable interposer and the plurality of integrated circuits.

13. The multichip package defined in claim 11, further comprising:

an additional configurable interposer that is stacked on top of the configurable interposer; and

another plurality of integrated circuits that are mounted on the additional configurable interposer in the package housing.

14. The multichip package defined in claim 11, wherein a given integrated circuit in the plurality of integrated circuits includes logic circuits and debugging circuitry, and wherein the logic circuits generate user signals that are conveyed to the debugging circuitry via at least one signal routing path in the programmable interconnect routing circuitry.

15. The multichip package defined in claim 11, wherein a first integrated circuit in the plurality of integrated circuits includes logic circuits, wherein a second integrated circuit in the plurality of integrated circuits comprises a debug processor, and wherein the logic circuits of the first integrated circuit generate user signals that are conveyed to the debug processor via at least one signal routing path in the programmable interconnect routing circuitry.

16. The multichip package defined in claim 11, wherein a given integrated circuit in the plurality of integrated circuits

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includes logic circuits, wherein the configurable interposer further includes debug logic embedded as an integral part of the configurable interposer, and wherein the logic circuits in the given integrated circuit generate user signals that are conveyed to the interposer-embedded debug logic via at least one signal routing path in the programmable interconnect routing circuitry.

17. The multichip package defined in claim 11, further comprising:

debug circuitry, wherein a given integrated circuit in the plurality of integrated circuits includes logic circuits that generate test signals that are conveyed to the debug circuitry via a trace buffer.

18. A method for designing a multichip package using a circuit design tool implemented on computing equipment, wherein the multichip package includes a plurality of integrated circuits mounted on an interposer, the method comprising:

receiving a first input from a user that specifies how the plurality of integrated circuits is routed to the interposer; receiving a second input from the user that specifies input-output pins for the multichip package; and performing routing connections for the plurality of integrated circuits using programmable interconnect circuitry in the interposer based on the first and second user inputs.

19. The method defined in claim 18, further comprising: providing the user with an opportunity to select from a library of standard die footprints that serve as an interface between the interposer and the plurality of integrated circuits; and

receiving at least one standard die footprint that is selected by the user.

20. The method defined in claim 18, further comprising: generating configuration data for configuring the programmable interconnect circuitry so that the programmable interconnect circuitry provides desired routing connections for the plurality of integrated circuits.

21. The method defined in claim 18, further comprising: receiving additional input from the user that specifies circuits that are embedded within the interposer.

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